

# **ZD25WQ16B**

Ultra Low Power, 16M-bit Serial Multi I/O Flash Memory Datasheet

# **Performance Highlight**

- Wide Supply Range from 1.65 to 3.6V for Read, Erase and Program
- Ultra Low Power consumption 2.5mA for Read, Erase and Program
- X1, X2 and X4 Multi I/O Support
- High reliability with 100K cycling and 20Year-retention
- Page/Sector/Block Erase
- Fast Chip Erase time 10ms



# Contents

1.3.       Software features.       5         1.4.       Hardware features.       5         1.4.       Hardware features.       5         Description.       6         2.1.       Pin Definition.       7         2.2.       Block Diagram.       7         2.3.       Memory Address Mapping.       8         3.       Memory Address Mapping.       9         3.1.       Model and Mode3.       9         3.2.       IO MODE.       9         3.3.       Hold Feature.       10         3.4.       Status Register.       11         3.5.       Configure Register.       12         3.6.       Data Protection.       12         3.6.       Data Protections.       16         4.1.       Absolute Maximum Ratings.       16         4.2.       DC Characteristics.       17         4.3.       AC Characteristics for Program and Erase.       19         4.5.       Operation Conditions.       21         5.1.       Commands.       23         5.2.       Write Enable (WRD).       26         5.3.       Write Enable (WRD).       26         5.4.       Read Configure Registe	1.	Overvie	2W	4
1.3.       Software features       5         1.4.       Hardware features       5         1.4.       Hardware features       5         2. Description       6       2.1.         Pin Definition       7       2         Block Diagram       7       2.3.       Memory Address Mapping.       8         3. Device Operation       9       3.1.       Mode0 and Mode3.       9         3.1.       Mode0 and Mode3.       9       9       3.3.       Hold Feature       10         3.4.       Status Register       11       11       3.5.       Configure Register       12         3.6.       Data Protection       12       3.6.       Data Protection       16         4.1.       Absolute Maximum Ratings       16       4.1.       Absolute Maximum Ratings       16         4.2.       DC Characteristics.       17       4.3.       AC Characteristics       17         4.3.       AC Characteristics for Program and Erase       19       4.5.       Operation Conditions       21         5.1.       Commands       151       Commands       23       51.       Commands       23         5.2.       Write Enable (WREN)       26       26		1.1.	General	4
1.4.       Hardware features.       5         2. Description.       6         2.1.       Pin Definition.       7         2.2.       Block Diagram.       7         2.3.       Memory Address Mapping.       8         3. Device Operation.       9         3.1.       Model and Mode3.       9         3.2.       IO MODE.       9         3.3.       Hold Feature.       10         3.4.       Status Register.       11         3.5.       Configure Register.       12         3.6.       Data Protection       12         4.       Electrical Specifications.       16         4.1.       Absolute Maximum Ratings.       16         4.1.       Absolute Maximum Ratings.       16         4.1.       Absolute Maximum Ratings.       16         4.4.       AC Characteristics.       17         4.3.       AC Characteristics.       18         4.4.       AC Characteristics.       12         5.       Operation Conditions.       21         5.       Commands.       23         5.1.       Commands listing.       23         5.2.       Write Enable (WRD).       26		1.2.	Performance	4
2.       Description		1.3.	Software features	5
2.1.       Pin Definition       7         2.2.       Block Diagram.       7         2.3.       Memory Address Mapping.       8         3.       Device Operation.       9         3.1.       Mode0 and Mode3.       9         3.2.       IO MODE       9         3.3.       Hold Feature.       10         3.4.       Status Register       11         3.5.       Configure Register.       12         3.6.       Data Protection.       12         3.6.       Data Protections.       16         4.1.       Absolute Maximum Ratings.       16         4.2.       DC Characteristics.       17         4.3.       AC Characteristics.       17         4.3.       AC Characteristics.       18         4.4.       A C Characteristics.       12         5.5.       Commands listing       23         5.1.       Commands listing       23         5.2.       Write Enable (WREN).       26         5.3.       Write Enable (WRED).       26         5.4.       Write Enable (WRED).       26         5.7.       Read Configure Register (RDCR).       28         5.8.       R		1.4.	Hardware features	5
2.2.       Block Diagram	2.	Descrip	tion	6
2.3.       Memory Address Mapping.       8         3.       Device Operation.       9         3.1.       Mode0 and Mode3.       9         3.2.       IO MODE.       9         3.3.       Hold Feature.       10         3.4.       Status Register.       11         3.5.       Configure Register.       12         3.6.       Data Protection.       12         4.       Absolute Maximum Ratings.       16         4.1.       Absolute Maximum Ratings.       16         4.2.       DC Characteristics.       17         4.3.       AC Characteristics or Program and Erase.       19         4.5.       Operation Conditions.       21         5.1.       Commands.       23         5.1.       Commands listing.       23         5.2.       Write Enable (WREN)       26         5.3.       Write Enable (WREN)       26         5.4.       Write Enable (WREN)       26         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDSR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRSR).		2.1.	Pin Definition	7
3. Device Operation.       9         3.1. Mode0 and Mode3.       9         3.2. IO MODE       9         3.3. Hold Feature.       10         3.4. Status Register.       11         3.5. Configure Register.       12         3.6. Data Protection.       12         3.6. Data Protection.       12         4. Electrical Specifications.       16         4.1. Absolute Maximum Ratings.       16         4.2. DC Characteristics.       17         4.3. AC Characteristics for Program and Erase.       19         4.4. AC Characteristics for Program and Erase.       19         4.5. Operation Conditions.       21         5.1. Commands listing.       23         5.2. Write Enable (WREN).       26         5.3. Write Disable (WRDI).       26         5.4. Write Enable for Volatile Status Register.       27         5.5. Read Status Register (RDSR).       28         5.6. Read Configure Register (WRSR).       29         5.8. Write Status Interrupt (ASI).       29         5.9. Write Configure Register (WRSR).       30         5.10. Read Data Bytes (R RAD).       31         5.11. Read Data Bytes (R RAD).       31         5.13. Quad Read Mode (QREAD).       35		2.2.	Block Diagram	7
3. Device Operation.       9         3.1. Mode0 and Mode3.       9         3.2. IO MODE       9         3.3. Hold Feature.       10         3.4. Status Register.       11         3.5. Configure Register.       12         3.6. Data Protection.       12         3.6. Data Protection.       12         4. Electrical Specifications.       16         4.1. Absolute Maximum Ratings.       16         4.2. DC Characteristics.       17         4.3. AC Characteristics for Program and Erase.       19         4.4. AC Characteristics for Program and Erase.       19         4.5. Operation Conditions.       21         5.1. Commands listing.       23         5.2. Write Enable (WREN).       26         5.3. Write Disable (WRDI).       26         5.4. Write Enable for Volatile Status Register.       27         5.5. Read Status Register (RDSR).       28         5.6. Read Configure Register (WRSR).       29         5.8. Write Status Interrupt (ASI).       29         5.9. Write Configure Register (WRSR).       30         5.10. Read Data Bytes (R RAD).       31         5.11. Read Data Bytes (R RAD).       31         5.13. Quad Read Mode (QREAD).       35		2.3.	Memory Address Mapping	8
3.1       Mode0 and Mode3	3.	Device		
3.3.       Hold Feature.       10         3.4.       Status Register.       11         3.5.       Configure Register.       12         3.6.       Data Protection.       12         3.6.       Data Protection.       12         4.       Electrical Specifications.       16         4.1.       Absolute Maximum Ratings.       16         4.2.       DC Characteristics.       17         4.3.       AC Characteristics for Program and Erase.       19         4.5.       Operation Conditions.       21         5.1.       Commands listing.       23         5.2.       Write Enable (WREN).       26         5.3.       Write Enable for Volatile Status Register.       27         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRSR).       29         5.9.       Write Configure Register (WRCR).       30         5.10.       Read Mode (DREAD).       31         5.11.       Read Data Bytes (READ).       31         5.12.       Dual Read Mode (QREAD).       33     <			Mode0 and Mode3	9
3.4.       Status Register.       11         3.5.       Configure Register.       12         3.6.       Data Protection.       12         3.6.       Data Protection.       12         4.       Electrical Specifications.       16         4.1.       Absolute Maximum Ratings.       16         4.2.       DC Characteristics.       17         4.3.       AC Characteristics for Program and Erase.       19         4.5.       Operation Conditions.       21         5.       Commands       23         5.1.       Commands listing.       23         5.2.       Write Enable (WREN).       26         5.3.       Write Disable (WRDI).       26         5.4.       Write Enable for Volatile Status Register.       27         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRSR).       29         5.9.       Write Status Register (WRCR).       30         5.10.       Read Data Bytes (READ).       31         5.11.       Read Data Bytes (READ).       31		3.2.	IO MODE	9
3.5.       Configure Register		3.3.	Hold Feature	10
3.6.       Data Protection.       12         4.       Electrical Specifications.       16         4.1.       Absolute Maximum Ratings.       16         4.2.       DC Characteristics.       17         4.3.       AC Characteristics.       17         4.3.       AC Characteristics for Program and Erase.       19         4.5.       Operation Conditions.       21         5. Commands.       23         5.1.       Commands listing.       23         5.2.       Write Enable (WREN).       26         5.3.       Write Disable (WRDI).       26         5.4.       Write Enable for Volatile Status Register       27         5.5.       Read Configure Register (RDCR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRCR).       30         5.10.       Read Data Bytes (READ).       31         5.11.       Read Data Bytes (READ).       31         5.12.       Dual Read Mode (DREAD).       35         5.13.       2 X IO Read Mode (READ).       36         5.14.       2 X IO Read Mode (READ).       36		3.4.	Status Register	11
4.       Electrical Specifications.       16         4.1.       Absolute Maximum Ratings.       16         4.2.       DC Characteristics.       17         4.3.       AC Characteristics.       18         4.4.       AC Characteristics.       18         4.4.       AC Characteristics.       18         4.4.       AC Characteristics.       19         4.5.       Operation Conditions.       21         5.       Commands.       23         5.1.       Commands listing.       23         5.2.       Write Enable (WREN).       26         5.3.       Write Disable (WRDI)       26         5.4.       Write Enable for Volatile Status Register.       27         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRCR).       29         5.9.       Write Configure Register (WRCR).       30         5.10.       Read Data Bytes at Higher Speed (FAST_READ).       31         5.12.       Dual Read Mode (DREAD).       33         5.13.       2 X IO Read Mode (QREAD).       35<		3.5.	Configure Register	.12
4.1.       Absolute Maximum Ratings		3.6.	Data Protection	12
42.       DC Characteristics.       17         43.       AC Characteristics.       18         44.       AC Characteristics for Program and Erase.       19         45.       Operation Conditions.       21         5.       Operation Conditions.       23         5.1.       Commands.       23         5.2.       Write Enable (WREN).       26         5.3.       Write Disable (WRDI).       26         5.4.       Write Enable for Volatile Status Register.       27         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRSR).       29         5.8.       Write Configure Register (WRCR).       30         5.10.       Read Data Bytes (READ).       31         5.11.       Read Data Bytes (READ).       31         5.12.       Dual Read Mode (DREAD).       33         5.13.       2 X IO Read Performer Enhance Mode.       35         5.15.       Quad Read Mode (QREAD).       36         5.16.       4 X IO Read Performance Enhance.       38         5.17.       4 X IO ReadP	4.	Electric	al Specifications	16
4.3.       AC Characteristics.       18         4.4.       AC Characteristics for Program and Erase.       19         4.5.       Operation Conditions.       21         5.       Commands.       23         5.1.       Commands listing.       23         5.2.       Write Enable (WREN).       26         5.3.       Write Enable (WRDI).       26         5.4.       Write Enable for Volatile Status Register.       27         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRCR).       29         5.9.       Write Configure Register (WRCR).       30         5.10.       Read Data Bytes (READ).       31         5.11.       Read Mode (DREAD).       33         5.12.       Dual Read Mode (2READ).       34         5.14.       2 X IO Read Mode (2READ).       34         5.15.       Quad Read Mode (QREAD).       36         5.16.       4 X IO ReadPerformance Enhance.       38         5.15.       Quad Read Mode (QREAD).       37         5.17.       4 X IO ReadPerformance E		4.1.	Absolute Maximum Ratings	.16
4.4.       AC Characteristics for Program and Erase.       19         4.5.       Operation Conditions.       21         5.       Commands.       23         5.1.       Commands listing.       23         5.2.       Write Enable (WREN).       26         5.3.       Write Disable (WRDI).       26         5.4.       Write Enable for Volatile Status Register       27         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Iterrupt (ASI).       29         5.8.       Write Status Register (WRSR).       29         5.9.       Write Configure Register (WRCR).       30         5.10.       Read Data Bytes (READ).       31         5.11.       Read Mode (DREAD).       31         5.12.       Dual Read Mode (2READ).       33         5.13.       Quad Read Mode (QREAD).       36         5.14.       2 X IO Read Performer Enhance Mode.       35         5.15.       Quad Read Mode (QREAD).       36         5.16.       4 X IO ReadPerformance Enhance.       38         5.18.       Burst Read.       39         5.19.       Page Erase (PE).		4.2.	DC Characteristics	.17
4.5.       Operation Conditions.       21         5.       Commands       23         5.1.       Commands listing.       23         5.2.       Write Enable (WREN).       26         5.3.       Write Disable (WRDI).       26         5.4.       Write Enable for Volatile Status Register.       27         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRSR).       29         5.9.       Write Configure Register (WRCR).       30         5.10.       Read Data Bytes (READ).       31         5.11.       Read Mode (DREAD).       31         5.12.       Dual Read Mode (DREAD).       33         5.13.       2 X IO Read Mode (2READ).       34         5.14.       2 X IO Read Mode (2READ).       36         5.15.       Quad Read Mode (4READ).       37         5.17.       4 X IO Read Mode (4READ).       36         5.18.       Burst Read.       39         5.19.       Page Erase (PE).       39         5.20.       Sector Erase (SE).       40 <tr< td=""><td></td><td>4.3.</td><td>AC Characteristics</td><td>.18</td></tr<>		4.3.	AC Characteristics	.18
4.5.       Operation Conditions.       21         5.       Commands       23         5.1.       Commands listing.       23         5.2.       Write Enable (WREN).       26         5.3.       Write Disable (WRDI).       26         5.4.       Write Enable for Volatile Status Register       27         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRSR).       29         5.9.       Write Configure Register (WRCR).       30         5.10.       Read Data Bytes (READ).       31         5.11.       Read Data Bytes at Higher Speed (FAST_READ).       31         5.12.       Dual Read Mode (DREAD).       33         5.13.       2 X IO Read Mode (2READ).       34         5.14.       2 X IO Read Mode (2READ).       36         5.15.       Quad Read Mode (4READ).       37         5.17.       4 X IO Read Performance Enhance       38         5.18.       Burst Read.       39         5.19.       Page Erase (PE).       39         5.20.       Sector Erase (SE).		4.4.	AC Characteristics for Program and Erase	. 19
5.1.       Commands listing		4.5.	e e	
5.2.       Write Enable (WREN)	5.	Comma	1	
5.2.       Write Enable (WREN)		5.1.	Commands listing	.23
5.4.       Write Enable for Volatile Status Register.       27         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRSR).       29         5.9.       Write Configure Register (WRCR).       30         5.10.       Read Data Bytes (READ).       31         5.11.       Read Data Bytes at Higher Speed (FAST_READ).       31         5.12.       Dual Read Mode (DREAD).       33         5.13.       2 X IO Read Mode (2READ).       34         5.14.       2 X IO Read Performer Enhance Mode.       35         5.15.       Quad Read Mode (QREAD).       36         5.16.       4 X IO ReadPerformance Enhance       38         5.18.       Burst Read.       39         5.19.       Page Erase (PE).       39         5.20.       Sector Erase (SE).       40         5.21.       Block Erase (BE32K).       40         5.22.       Block Erase (CE).       41         5.23.       Chip Erase (CE).       41         5.24.       Page Program (PP).       42         5.25.       Dual Inpu		5.2.	6	
5.4.       Write Enable for Volatile Status Register.       27         5.5.       Read Status Register (RDSR).       28         5.6.       Read Configure Register (RDCR).       28         5.7.       Active Status Interrupt (ASI).       29         5.8.       Write Status Register (WRSR).       29         5.9.       Write Configure Register (WRCR).       30         5.10.       Read Data Bytes (READ).       31         5.11.       Read Data Bytes at Higher Speed (FAST_READ).       31         5.12.       Dual Read Mode (DREAD).       33         5.13.       2 X IO Read Mode (2READ).       34         5.14.       2 X IO Read Mode (QREAD).       36         5.15.       Quad Read Mode (QREAD).       36         5.16.       4 X IO ReadPerformance Enhance       38         5.18.       Burst Read.       39         5.19.       Page Erase (PE).       39         5.20.       Sector Erase (SE).       40         5.21.       Block Erase (BE32K).       40         5.22.       Block Erase (CE).       41         5.23.       Chip Erase (CE).       41         5.24.       Page Program (PP).       43		5.3.		
5.5.       Read Status Register (RDSR)		5.4.		
5.7.       Active Status Interrupt (ASI)		5.5.	Read Status Register (RDSR)	28
5.7.       Active Status Interrupt (ASI)		5.6.	e ( )	
5.8.       Write Status Register (WRSR).       29         5.9.       Write Configure Register (WRCR).       30         5.10.       Read Data Bytes (READ).       31         5.11.       Read Data Bytes at Higher Speed (FAST_READ).       31         5.12.       Dual Read Mode (DREAD).       33         5.13.       2 X IO Read Mode (2READ).       34         5.14.       2 X IO Read Performer Enhance Mode.       35         5.15.       Quad Read Mode (QREAD).       36         5.16.       4 X IO Read Mode (4READ).       36         5.17.       4 X IO Read Performance Enhance.       38         5.18.       Burst Read.       39         5.19.       Page Erase (PE).       39         5.20.       Sector Erase (SE).       40         5.21.       Block Erase (BE32K).       40         5.22.       Block Erase (BE).       41         5.23.       Chip Erase (CE).       41         5.24.       Page Program (PP).       42         5.25.       Dual Input Page Program (DPP).       43		5.7.		
5.9.       Write Configure Register (WRCR)		5.8.	1 ( )	
5.10.       Read Data Bytes (READ)		5.9.		
5.11.       Read Data Bytes at Higher Speed (FAST_READ).       31         5.12.       Dual Read Mode (DREAD).       33         5.13.       2 X IO Read Mode (2READ).       34         5.14.       2 X IO Read Performer Enhance Mode.       35         5.15.       Quad Read Mode (QREAD).       36         5.16.       4 X IO Read Mode (4READ).       36         5.17.       4 X IO Read Performance Enhance.       38         5.18.       Burst Read.       39         5.19.       Page Erase (PE).       39         5.20.       Sector Erase (SE).       40         5.21.       Block Erase (BE32K).       40         5.22.       Block Erase (BE).       41         5.23.       Chip Erase (CE).       41         5.24.       Page Program (PP).       42         5.25.       Dual Input Page Program (DPP).       43		5.10.		
5.12.       Dual Read Mode (DREAD).       33         5.13.       2 X IO Read Mode (2READ).       34         5.14.       2 X IO Read PerformerEnhance Mode.       35         5.15.       Quad Read Mode (QREAD).       36         5.16.       4 X IO Read Mode (4READ).       36         5.17.       4 X IO Read Mode (4READ).       37         5.17.       4 X IO ReadPerformance Enhance.       38         5.18.       Burst Read.       39         5.19.       Page Erase (PE).       39         5.20.       Sector Erase (SE).       40         5.21.       Block Erase (BE32K).       40         5.22.       Block Erase (BE).       41         5.23.       Chip Erase (CE).       41         5.24.       Page Program (PP).       42         5.25.       Dual Input Page Program (DPP).       43		5.11.	• • •	
5.13.       2 X IO Read Mode (2READ)		5.12.		
5.14.       2 X IO Read PerformerEnhance Mode.       35         5.15.       Quad Read Mode (QREAD)		5.13.		
5.15.       Quad Read Mode (QREAD)		5.14.	2 X IO Read Performer Enhance Mode.	35
5.17.       4 X IO ReadPerformance Enhance		5.15.		
5.18.       Burst Read		5.16.	4 X IO Read Mode (4READ)	.37
5.19.       Page Erase (PE)		5.17.	4 X IO ReadPerformance Enhance	.38
5.20.       Sector Erase (SE)		5.18.	Burst Read.	39
5.20.       Sector Erase (SE)		5.19.	Page Erase (PE)	.39
5.22.       Block Erase (BE)		5.20.	Sector Erase (SÉ)	.40
5.22.       Block Erase (BE)		5.21.		
5.23.       Chip Erase (CE)		5.22.		
5.24.Page Program (PP)		5.23.		
5.25. Dual Input Page Program (DPP)			- · · · ·	
		5.25.		
		5.26.		

# Zetta

8.

	5.27.	Erase Security Registers (ERSCUR)	45
	5.28.	Program Security Registers (PRSCUR)	46
	5.29.	Erase Security Registers (RDSCUR)	47
	5.30.	Deep Power-down (DP)	48
	5.31.	Release form Deep Power-Down (RDP), Read Electronic Signature (RES)	49
	5.32.	Read Electronic Manufacturer ID & Device ID (REMS)	50
	5.33.	Dual I/O Read Electronic Manufacturer ID & Device ID (DREMS)	
	5.34.	Quad I/O Read Electronic Manufacturer ID & Device ID (QREMS)	
	5.35.	Read Identification (RDID)	
	5.36.	Program/Erase Suspend/Resume	
	5.37.	Erase Suspend to Program	55
	5.38.	Program Resume and Erase Resume	55
	5.39.	No Operation (NOP)	56
	5.40.	Software Reset (RSTEN/RST)	56
	5.41.	Read Unique ID (RUID)	57
	5.42.	Read SFDP Mode (RDSFDP)	
6.	Orderin	g Information	63
7.	Package	Information	64
	7.1.	8-Lead SOP(150mil)	64
	7.2.	8-Lead SOP(208mil)	65
	7.3.	8-Lead TSSOP(173mil)	66
	7.4.	8-Land USON(3x2mm,0.55mm)	67
	7.5.	8-Land USON(3x2mm,0.50mm).	
8.	Revisior	ו History	
		-	



# 1. Overview

# 1.1. General

- Single 1.65V to 3.60V supply
  - 1.65V-3.6V for Read, Erase and Program Operations
- Industrial Temperature Range -40C to 85C
- Serial Peripheral Interface (SPI) Compatible:
  - Mode 0 and Mode 3
- Single, Dual and Quad IO mode
  - 16M x 1 bit
  - 8M x 2 bits
  - 4M x 4 bits
- Flexible Architecture for Code and Data Storage
  - Uniform 256-byte Page Program
  - Uniform 256-byte Page Erase
  - Uniform 4K-byte Sector Erase
  - Uniform 32K/64K-byte Block Erase
  - Full Chip Erase

# 1.2. Performance

- Fast read
  - 4 I/O 104MHz with 2+4 dummy cycles, equivalent to 320M
  - 2 I/O 104MHz with 4 dummy cycles, equivalent to 160M
  - 1 I/O 104MHz with 8 dummy cycles
- Fast Program and Erase Speed
  - 1.3ms Page program time
  - 10ms Page erase time
  - 10ms 4K-byte sector erase time
  - 10ms 32K-byte block erase time
  - 10ms 64K-byte block erase time
- Burst read
  - 8/16/32/64 byte Wrap-Aroud
- Ultra Low Power Consumption
  - 0.1uA Deep Power Down current
  - 12uA Standby current
  - 4mA Active Read current at 33MHz
  - 6mA Active Program or Erase current
- High Reliability
  - 100,000 Program / Erase Cycles
  - 20-year Data Retention



\_

# 1.3. Software features

- One Time Programmable (OTP) Security Register
  - 3\*512-Byte Security Registers With OTP Lock
- Software Protection Mode
  - The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits define the section of the memory array that can be read but not change.
- 128 bit unique ID for each device
- Program/Erase Suspend and Program/Erase Resume
- JEDEC Standard Manufacturer and Device ID Read Methodology

# 1.4. Hardware features

- Hardware Protection Mode
  - Hardware Controlled Locking of Protected Sectors by WP Pin
- Industry Standard Green Package Options
  - 8-pin SOP (150mil/208mil)
  - 8-land USON (3x2x0.55mm)
  - 8-land USON (3x2x0.50mm)
  - 8-pin TSSOP
  - WLCSP
  - KGD for SiP



# 2. Description

The ZD25WQ16B is a serial interface Flash memory device designed for use in a wide variety of high-volume consumer based applications in which program code is shadowed from Flash memory into embedded or external RAM for execution. The flexible erase architecture of the device, with its page erase granularity it is ideal for data storage as well, eliminating the need for additional data storage devices.

The erase block sizes of the device have been optimized to meet the needs of today's code and data storage applications. By optimizing the size of the erase blocks, the memory space can be used much more efficiently. Because certain code modules and data storage segments must reside by themselves in their own erase regions, the wasted and unused memory space that occurs with large sectored and large block erase Flash memory devices can be greatly reduced. This increased memory space efficiency allows additional code routines and data storage segments to be added while still maintaining the same overall device density.

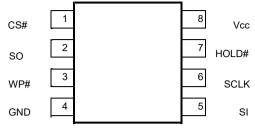
The device also contains an additional 3\*512-byte security registers with OTP lock (One-Time Programmable), can be used for purposes such as unique device serialization, system-level Electronic Serial Number (ESN) storage, locked key storage, etc.

Specifically designed for use in many different systems, the device supports read, program, and erase operations with a wide supply voltage range of 1.65V to 3.6V. No separate voltage is required for programming and erasing.



# 2.1. Pin Definition

# **Pin Configurations**

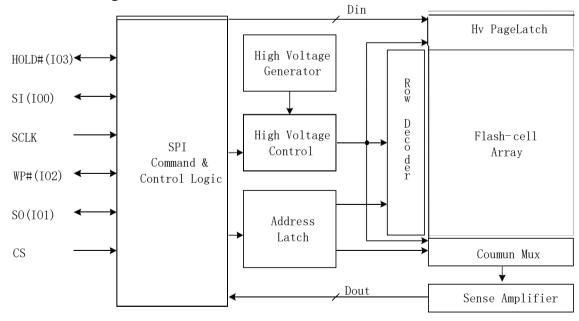


8-PIN SOP (150mil/200mil) and TSSOP

### **Pin Descriptions**

No.	Symbol	Extension	Remarks				
1	CS#		Chip select				
2	SO	SIO1	Serial data output for 1 x I/O Serial data input and output for 4 x I/O read mode				
3	WP#	SIO2 Write protection active low Serial data input and output for 4 x I/O read mode					
4	GND	-	Ground of the device				
5	SI	SIO0	Serial data input for 1x I/O Serial data input and output for 4 x I/O read mode				
6	SCLK	-	Serial interface clock input				
7	HOLD#	SIO3	To pause the device without deselecting the device Serial data input and output for 4 x I/O read mode				
8	VCC	-	Power supply of the device				

# 2.2. Block Diagram





# 2.3. Memory Address Mapping

The memory array can be erased in three levels of granularity including a full chip erase. The size of the erase blocks is optimized for both code and data storage applications, allowing both code and data segments to reside in their own erase regions.

### ZD25WQ16B Memory Organization

Block64K	Block32K	Sector	Address	Range
	<u>_</u>	512	1FF000H	1FFFFFH
31	63 - 62			
	Ň	496	1F0000H	1F0FFFH
	6	495	1EF000H	1EFFFFH
30	61 - 60			
	õ	480	1E0000H	1E0FFFH
•••••				
•••••				
		47	02F000H	02FFFFH
2	5 - 4			
		32	020000Н	020FFFH
		31	01F000H	01FFFFH
1	3 - 2			
		16	010000H	010FFFH
		15	00F000H	00FFFFH
0	1 - 0			
		0	000000Н	000FFFH



# 3. Device Operation

# 3.1. Mode0 and Mode3

Before a command is issued, status register should be checked to ensure device is ready for the intended operation.

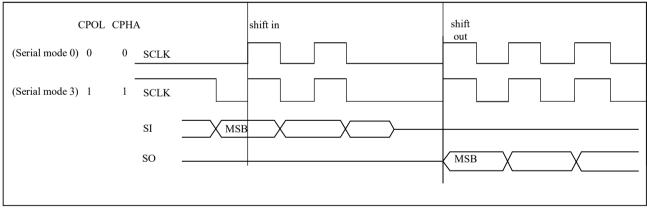
When incorrect command is inputted to this LSI, this LSI becomes standby mode and keeps the standby mode until next CS# falling edge. In standby mode, SO pin of this LSI should be High-Z. When correct command is inputted to this LSI, this LSI becomes active mode and keeps the active mode until next CS# rising edge.

Input data is latched on the rising edge of Serial Clock (SCLK) and data shifts out on the falling edge of SCLK. The difference of serial peripheral interface mode 0 and mode 3 is shown as Figure 9-1.

For the following instructions: RDID, RDSR, RDSR1, RDSCUR, READ, FAST\_READ, DREAD, 2READ, 4READ, QREAD, RDSFDP, RES, REMS, DREMS, QREMS, the shifted-in instruction sequence is followed by a data-out sequence. After any bit of data being shifted out, the CS# can be high. For the following instructions: WREN, WRDI, WRSR, PE, SE, BE32K, BE, CE, PP, DPP, QPP, DP, ERSCUR, PRSCUR, SUSPEND, RESUME, RSTEN, RST, the CS# must go high exactly at the byte boundary; otherwise, the instruction will be rejected and not executed.

During the progress of Write Status Register, Program, Erase operation, to access the memory array is neglected and not affect the current operation of Write Status Register, Program, Erase.





Note:

CPOL indicates clock polarity of serial master, CPOL=1 for SCLK high while idle, CPOL=0 for SCLK low while not transmitting. CPHA indicates clock phase. The combination of CPOL bit and CPHA bit decides which serial mode is supported.

# 3.2. IO MODE

### Standard SPI

The ZD25WQ16B features a serial peripheral interface on 4 signals bus: Serial Clock (SCLK), Chip Select (CS#), Serial Data Input (SI) and Serial Data Output (SO). Both SPI bus mode 0 and 3 are supported. Input data is latched on the rising edge of SCLK and data shifts out on the falling edge of SCLK.

### Dual SPI

The ZD25WQ16B supports Dual SPI operation when using the "Dual Output Fast Read" and "Dual I/O Fast



Read"(3BHand BBH) commands. These commands allow data to be transferred to or from the device

at two times the rate of the standard SPI. When using the Dual SPI command the SI and SO pins become bidirectional I/O pins: IO0 and IO1.

### Quad SPI

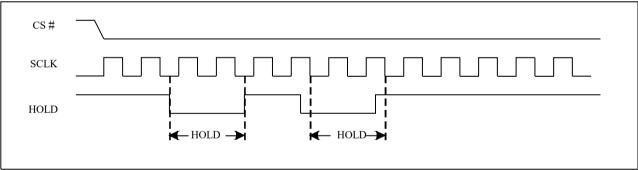
The ZD25WQ16B supports Quad SPI operation when using the "Quad Output Fast Read"," Quad I/O Fast Read"(6BH,EBH) commands. These commands allow data to be transferred to or from the device at four times the rate of the standard SPI. When using the Quad SPI command the SI and SO pins become bidirectional I/O pins: IO0 and IO1, and WP# and HOLD# pins become IO2 andIO3. Quad SPI commands require the non-volatile Quad Enable bit(QE) in Status Register to be set.

# 3.3. Hold Feature

HOLD# pin signal goes low to hold any serial communications with the device. The HOLD feature will not stop the operation of write status register, programming, or erasing in progress

The operation of HOLD requires Chip Select(CS#) keeping low and starts on falling edge of HOLD# pin signal while Serial Clock (SCLK) signal is being low (if Serial Clock signal is not being low, HOLD operation will not start until Serial Clock signal being low). The HOLD condition ends on the rising edge of HOLD# pin signal while Serial Clock(SCLK) signal is being low( if Serial Clock signal is not being low, HOLD operation will not end until Serial Clock being low).

### Figure 3-2 Hold Condition Operation



During the HOLD operation, the Serial Data Output (SO) is high impedance when Hold# pin goes low and will keep high impedance until Hold# pin goes high. The Serial Data Input (SI) is don't care if both Serial Clock (SCLK) and Hold# pin goes low and will keep the state until SCLK goes low and Hold# pin goes high. If Chip Select (CS#) drives high during HOLD operation, it will reset the internal logic of the device. To re-start communication with chip, the HOLD# must be at high and CS# must be at low.

**Note:** The HOLD feature is disabled during Quad I/O mode.

# 3.4. Status Register

S15	S14	S13	S12	S11	S10	S9	S8
SUS1	CMP	LB3	LB2	LB1	SUS2	QE	SRP1
S7	S6	S5	S4	S3	S2	S1	S0
SRP0	BP4	BP3	BP2	BP1	BP0	WEL	WIP

The definition of the status register bits is as below:

### WIP bit.

The Write in Progress (WIP) bit indicates whether the memory is busy in program/erase/write status register progress. When WIP bit sets to 1, means the device is busy in program/erase/write status register progress, when WIP bit sets 0, means the device is not in program/erase/write status register progress.

### WEL bit.

The Write Enable Latch (WEL) bit indicates the status of the internal Write Enable Latch. When set to 1 the internal Write Enable Latch is set, when set to 0 the internal Write Enable Latch is reset and no Write Status Register, Program or Erase command is accepted.

### BP4, BP3, BP2, BP1, BP0 bits.

The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits are non-volatile. They define the size of the area to be software protected against Program and Erase commands. These bits are written with the Write Status Register (WRSR) command. When the Block Protect (BP4, BP3, BP2, BP1, BP0) bits are set to 1, the relevant memory area (as defined in Table "Protected Area Sizes").becomes protected against Page Program (PP), Page Erase (PE), Sector Erase (SE) and Block Erase (BE) commands. The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits can be written provided that the Hardware Protected mode has not been set. The Chip Erase (CE) command is executed, only if the Block Protect (BP4, BP3, BP2, BP1and BP0) are set to "None protected".

### SRP1, SRP0 bits.

The Status Register Protect (SRP1 and SRP0) bits are non-volatile Read/Write bits in the status register. The SRP bits control the method of write protection: software protection, hardware protection, power supply lock-down or one time programmable protection

SRP1	SRP0	WP#	Status Register	Description				
0	0	x	Software Protected	The Status Register can be written to after a Write Enable command, WEL=1.(Default)				
0	1	0	Hardware Protected	WP#=0, the Status Register locked and can not be write to.				
0	1	1	Hardware Unprotected	WP#=1, the Status Register is unlocked and can be written to after a Write Enable command, WEL=1.				
1	0	x	Power Supply Lock-Down(1)	Status Register is protected and can not be written to again until the next Power-Down, Power-Up cycle.				
1	1	x	One Time Program(2)	Status Register is permanently protected and can not be written to.				

NOTE:

1. When SRP1, SRP0=(1, 0), a Power-Down, Power-Up cycle will change SRP1, SRP0 to (0, 0) state.

2. This feature is available on special order. Please contact Zetta fordetails.



### QE bit.

The Quad Enable (QE) bit is a non-volatile Read/Write bit in the Status Register that allows Quad operation. When the QE bit is set to 0 (Default) the WP# pin and HOLD# pin are enable. When the QE pin is set to 1, the Quad IO2 and IO3 pins are enabled. (The QE bit should never be set to 1 during standard SPI or Dual SPI operation if the WP# or HOLD# pins are tied directly to the power supply or ground)

### LB3, LB2, LB1, bits.

The LB3, LB2, LB1, bits are non-volatile One Time Program (OTP) bits in Status Register (S13-S11) that provide the write protect control and status to the Security Registers. The default state of LB3-LB1are0, the security registers are unlocked. The LB3-LB1bitscan be set to 1 individually using the Write Register instruction. The LB3-LB1bits are One Time Programmable, once its set to 1, the Security Registers will become read-only permanently.

### CMP bit

The CMP bit is a non-volatile Read/Write bit in the Status Register(S14). It is used in conjunction the BP4-BP0 bits to provide more flexibility for the array protection. Please see the table "Protected Area Size" for details. The default setting is CMP=0.

### SUS1, SUS2bit

The SUS1 and SUS2bit are read only bit in the status register (S15and S10) that are set to 1 after interrupting an program/erase/write status register progress by Program/Erase Suspend (75H or B0H) command (The Erase Suspend will set the SUS1 to 1,and the Program Suspend will set the SUS2 to 1). The SUS1 and SUS2 bit are cleared to 0 by Program/Erase Resume (7AH or 30H) command as well as a power-down, power-up cycle.

### 3.5. Configure Register

S7	S6	S5	S4	S3	S2	S1	S0
DP	Reserved	Reserved	Reserved	Reserved	Reserved	Reserve	Reserved

The definition of the configure register bits is as below:

### DP bit.

The Dual Page (DP) bit is a non-volatile Read/Write bit in the Configure Register that allows Dual Page operation. When the DP bit is set to 0 (Default) the page size is 256bytes. When the DP pin is set to 1, the page size is 512bytes.

This bit controls the page programming buffer address wrap point. Legacy SPI devices generally have used a 256 Byte page programming buffer and defined that if data is loaded into the buffer beyond the 255 Byte location, the address at which additional bytes are loaded would be wrapped to address zero of the buffer. The P25Q08U provides a 512 Byte page programming buffer that can increase programming performance. For legacy software compatibility, this configuration bit provides the option to continue the wrapping behavior at the 256 Byte boundary or to enable full use of the available 512 Byte buffer by not wrapping the load address at the 256 Byte boundary.

When the DP pin is set to 1, the page erase instruction (81h) will erase the data of the chosen Dual Page to be "1".

# 3.6. Data Protection

During power transition, there may be some false system level signals which result in inadvertent erasure or programming. The device is designed to protect itself from these accidental write cycles. The state machine will be reset as standby mode automatically during power up. In addition, the control



register architecture of the device constrains that the memory contents can only be changed after specific command sequences have completed successfully.

In the following, there are several features to protect the system from the accidental write cycles during VCC power-up and power-down or from system noise.

• Power-on reset: to avoid sudden power switch by system power supply transition, the power-on reset may protect the Flash.

• Valid command length checking: The command length will be checked whether it is at byte base and completed on byte boundary.

• Write Enable (WREN) command: WREN command is required to set the Write Enable Latch bit (WEL) before issuing other commands to change data.

• Software Protection Mode: The Block Protect (BP4, BP3, BP2, BP1, and BP0) bits define the section of the memory array that can be read but not change.

- Hardware Protection Mode: WP# going low to protected the BP0~BP4bits and SRP0~1bits
- Deep Power-Down Mode: By entering deep power down mode, the flash device is under protected from writing all commands except the Release form Deep Power-Down Mode command.



St	atus Regi	ster Cor	ntent		Memory Content					
BP4	BP3	BP 2	BP1	BP 0	Blocks	Addresses	Density	Portion		
Х	Х	0	0	0	NONE	NONE	NONE	NONE		
0	0	0	0	1	31	1F0000H-1FFFFFH	64KB	Upper 1/32		
0	0	0	1	0	30 to 31	1E0000H-1FFFFFH	128KB	Upper 1/16		
0	0	0	1	1	28 to 31	1C0000H-1FFFFFH	256KB	Upper 1/8		
0	0	1	0	0	24 to 31	180000H-1FFFFFH	512KB	Upper 1/4		
0	0	1	0	1	16 to 31	100000H-1FFFFFH	1MB	Upper 1/2		
0	1	0	0	1	0	000000H-00FFFFH	64KB	Lower 1/32		
0	1	0	1	0	0 to 1	000000H-01FFFFH	128KB	Lower 1/16		
0	1	0	1	1	0 to 3	000000H-03FFFFH	256KB	Lower 1/8		
0	1	1	0	0	0 to 7	000000H-07FFFFH	512KB	Lower 1/4		
0	1	1	0	1	0 to 15	000000H-0FFFFFH	1MB	Lower 1/2		
Х	Х	1	1	Х	0 to 31	000000H-1FFFFFH	2MB	ALL		
1	0	0	0	1	31	1FF000H-1FFFFFH	4KB	Top Block		
1	0	0	1	0	31	1FE000H-1FFFFFH	8KB	Top Block		
1	0	0	1	1	31	1FC000H-1FFFFFH	16KB	Top Block		
1	0	1	0	Х	31	1F8000H-1FFFFFH 32KB		Top Block		
1	1	0	0	1	0	000000H-000FFFH 4KB		Bottom Block		
1	1	0	1	0	0	000000H-001FFFH 8KB		Bottom Block		
1	1	0	1	1	0	0 000000H-003FFFH 16KB Botto				
1	1	1	0	Х	0	0 000000H-007FFFH 32KB Bo				

### Table 3-1. Protected Area Sizes ZD25WQ16B Protected Area Sizes (CMP bit = 0)

### ZD25WQ16B Protected Area Sizes (CMP bit = 1)

,	Status Ro	egister C	ontent		Memory Content				
BP4	BP3	BP2	BP1	BP0	Blocks	Addresses	Density	Portion	
Х	Х	0	0	0	0 to 31	000000H-1FFFFFH	2MB	ALL	
0	0	0	0	1	0 to 30	000000H-1EFFFFH	1984KB	Lower 31/32	
0	0	0	1	0	0 to 29	000000H-1DFFFFH	1920KB	Lower 15/16	
0	0	0	1	1	0 to 27	000000H-1BFFFFH	1792KB	Lower 7/8	
0	0	1	0	0	0 to 23	000000H-17FFFFH	1536KB	Lower 3/4	
0	0	1	0	1	0 to 15	000000H-0FFFFFH	1MB	Lower 1/2	
0	1	0	0	1	1 to 31	010000H-1FFFFFH	1984KB	Upper 31/32	
0	1	0	1	0	2 to 31	020000H-1FFFFFH	1920KB	Upper 15/16	
0	1	0	1	1	4 to 31	040000H-1FFFFH 1792KB		Upper 7/8	
0	1	1	0	0	8 to 31	080000H-1FFFFFH	1536KB	Upper 3/4	
0	1	1	0	1	16 to 31	100000H-1FFFFH 1MB		Upper 1/2	
Х	Х	1	1	Х	NONE	NONE	NONE	NONE	
1	0	0	0	1	0 to 31	000000H-1FEFFFH	2044KB	Lower 511/512	
1	0	0	1	0	0 to 31	000000H-1FDFFFH	2040KB	Lower 255/256	
1	0	0	1	1	0 to 31	000000H-1FBFFFH	2032KB	Lower 127/128	
1	0	1	0	Х	0 to 31	000000H-1F7FFFH	2016KB	Lower 63/64	
1	1	0	0	1	0 to 31	001000H-1FFFFFH 2044KB		Upper 511/512	
1	1	0	1	0	0 to 31	002000H-1FFFFFH 2040KB		Upper 255/256	
1	1	0	1	1	0 to 31	004000H-1FFFFH 2032KB U		Upper 127/128	
1	1	1	0	Х	0 to 31	008000H-1FFFFH 2016KB Upper 6			

Note:

1. X=don't care

2. If any erase or program command specifies a memory that contains protected data portion, this command will be ignored.



# 4. Electrical Specifications

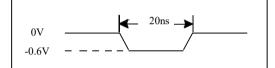
# 4.1. Absolute Maximum Ratings

Parameters	Value
Storage Temperature	-65°C to +150°C
Operation Temperature	40°C to +125°C
Maximum Operation Voltage	4.0V
Voltage on Any Pin with respect to Ground	-0.6V to + 4.1V
DC Output Current	5.0 mA

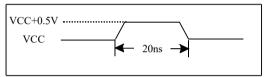
**NOTICE:** Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

#### Figure 4-1 Maximum Overshoot Waveform

Maxinum Negative Overshoot Waveform



Maxinum Positive Overshoot Waveform



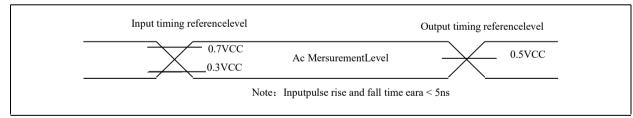
### Table 4-1 Pin Capacitance [1]

Symbol	Parameter	Max.	Units	Test Condition
Соит	Output Capacitance	8	pF	Vout=GND
C <sub>IN</sub>			pF	V <sub>IN</sub> =GND

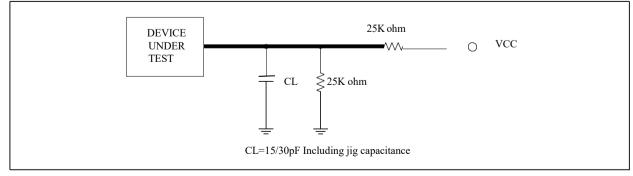
#### Note:

Test Conditions:  $T_A = 25^{\circ}C$ , F = 1MHz, Vcc = 3.0V.

#### Figure 4-2 Input Test Waveforms and Measurement Level



#### Figure 4-3 Output Loading





# 4.2. DC Characteristics

S	Parameter	Conditions	1.	65V to	2.3V	2.	.3V to 3	3.6V	Units
Sym.	rarameter	Conditions	Min.	Тур.	Max.	Min.	Тур.	Max.	Units
I <sub>DPD</sub>	Deep power down	CS#=Vcc, all other		0.5	1.5		0.5	1.5	uA
	current	inputs at 0V or Vcc							
I <sub>SB</sub>	Standby current	CS#, HOLD#, WP#=VIH		12			12		uA
		all inputs at CMOS							
I <sub>CC1</sub>	Low power read current (03h)	f=33MHz; IOUT=0mA		1.3	3.0		2.3	3.0	mA
T	Deed comment (0Dh)	f=80MHz; IOUT=0mA		1.8	4.0		2.8	4.0	mA
I <sub>CC2</sub>	Read current (0Bh)	f=85MHz; IOUT=0mA		-	-		2.8	4.5	mA
I <sub>CC3</sub>	Program current	CS#=Vcc		2.5	6.0		5.0	6.0	mA
I <sub>CC4</sub>	Erase current	CS#=Vcc		2.5	6.0		5.0	6.0	mA
I <sub>LI</sub>	Input load current	All inputs at CMOS			1.0			1.0	uA
IL	Output leakage	All inputs at CMOS			1.0			1.0	uA
0									
V <sub>IL</sub>	Input low voltage				0.2Vcc			0.3Vcc	V
V <sub>IH</sub>	Input high voltage		0.8Vcc			0.7Vcc			V
V <sub>OL</sub>	Output low voltage	IOL=100uA			0.2			0.2	V
V <sub>OH</sub>	Output high voltage	IOH=-100uA	Vcc-0.2			Vcc-0.2			V

# Table 4-2 DC parameters

### Note

1. Typical values measured at 1.8V @ 25°C for the 1.65V to 3.6V range.

2. Typical values measured at 3.0V @ 25°C for the 2.3V to 3.6V range.

# 4.3. AC Characteristics

Table 4-3 AC parameters

				1.65V~2.3V			2.3V~3.6V			
Symbol	Alt.	Parameter	min		max	min	min typ		Unit	
fSCLK	fC	Clock Frequency for the following instructions: FAST_READ, RDSFDP, PP, SE, BE32K, BE, CE, DP, RES,	D.C.		80			85	MHz	
fRSCLK	fR	Clock Frequency for READ instructions			33			33	MHz	
fTSCLK	fT	Clock Frequency for 2READ, DREAD instructions			80			85	MHz	
	fQ	Clock Frequency for 4READ,QREAD instructions			80			85	MHz	
fQPP		Clock Frequency for QPP (Quad page program)			80			85	MHz	
tCH(1)	tCLH	Clock High Time	5.5			4.5			ns	
tCL(1)	tCLL	Clock Low Time (fSCLK) 45% x (1fSCLK)	5.5			4.5			ns	
tCLCH(7)		Clock Rise Time (peak to peak)	0.1			0.1			ns/v	
tCHCL(7)		Clock Fall Time (peak to peak)	0.1			0.1			ns/v	
tSLCH	tCSS	CS# Active Setup Time (relative to SCLK)	5			5			ns	
tCHSL		CS# Not Active Hold Time (relative to SCLK)	5			5			ns	
tDVCH	tDSU	Data In Setup Time	2			2			ns	
tCHDX	tDH	Data In Hold Time	3			3			ns	
tCHSH		CS# Active Hold Time (relative to SCLK)	5			5			ns	
tSHCH		CS# Not Active Setup Time (relative to SCLK)	5			5			ns	
		CS# Deselect Time From Read to next Read	15			15			ns	
tSHSL	tCSH	CS# Deselect Time From Write,Erase,Program to Read Status Register	30			30			ns	
tSHQZ(7)	tDIS	Output Disable Time			6			6	ns	
tCLQV	tV	Clock Low to Output Valid Loading 30pF			7			7	ns	
ICLQ V	ιv	Clock Low to Output Valid Loading 15pF			6			6	ns	
tCLQX	tHO	Output Hold Time	0			0			ns	
tHLCH		HOLD# Active Setup Time (relative to SCLK)	7			5			ns	
tCHHH		HOLD# Active Hold Time (relative to SCLK)	5			5			ns	
tHHCH		HOLD# Not Active Setup Time (relative to SCLK)	5			5			ns	
tCHHL		HOLD# Not Active Hold Time (relative to SCLK)	5			5			ns	
tHHQX	tLZ	HOLD# to Output Low-Z			6			6	ns	
tHLQZ	tHZ	HOLD# to Output High-Z			6			6	ns	
tWHSL(3)		Write Protect Setup Time	20			20			ns	
tSHWL(3)		Write Protect Hold Time	100			100			ns	
tDP		CS# High to Deep Power-down Mode			3			3	us	
		CS# High To Standby Mode Without Electronic Signature								
tRES1		Read			8			8	us	
tRES2		CS# High To Standby Mode Without Electronic Signature Read			8			8	us	
tW		Write Status Register Cycle Time		8	12		8	12	ms	
tReady		Reset recovery time(for erase/program operation except WRSR)	80			80			us	
-		Reset recovery time(for WRSR operation)		8	12		8	12	ms	



# 4.4. AC Characteristics for Program and Erase

Table 4-4 AC paramete	rs fro prograi	n and erase
-----------------------	----------------	-------------

Sym.	Paramete		Units			
oym.	r	Min.	Тур.	Max.	Onits	
T <sub>ESL(6)</sub>	Erase Suspend Latency			80	us	
T <sub>PSL(6)</sub>	Program Suspend Latency			80	us	
T <sub>PRS(4)</sub>	Latency between Program Resume and next Suspend	0.3			us	
T <sub>ERS(5)</sub>	Latency between Erase Resume and next Suspend	0.3			us	
t <sub>PP</sub>	Page program time (up to 256 bytes)		1.3	3	ms	
t <sub>PE</sub>	Page erase time		10	12	ms	
t <sub>SE</sub>	Sector erase time		10	12	ms	
t <sub>BE1</sub>	Block erase time for 32K bytes		10	12	ms	
t <sub>BE2</sub>	Block erase time for 64K bytes		10	12	ms	
t <sub>CE</sub>	Chip erase time		10	12	ms	

### Note

1. tCH + tCL must be greater than or equal to 1/ Frequency.

2. Typical values given for TA=25°C. Not 100% tested.

3. Only applicable as a constraint for a WRSR instruction.

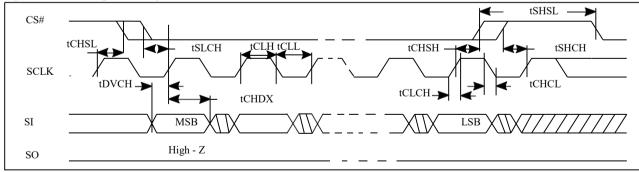
4. Program operation may be interrupted as often as system request. The minimum timing of tPRS must be observed before issuing the next program suspend command. However, in order for an Program operation to make progress, tPRS  $\geq$  100us must be included in resume-to-suspend loop(s). Not 100% tested.

5. Erase operation may be interrupted as often as system request. The minimum timing of tERS must be observed before issuing the next erase suspend command. However, in order for an Erase operation to make progress, tERS  $\geq$  200us must be included in resume-to-suspend loop(s). Notes. Not 100% tested.

6. Latency time is required to complete Erase/Program Suspend operation.

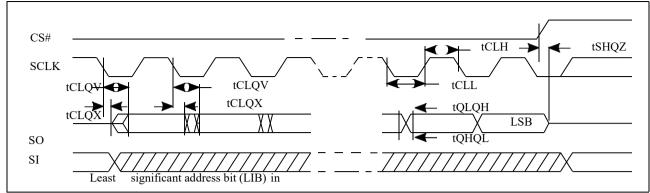
7. The value guaranteed by characterization, not 100% tested in production.

### Figure 4-4 Serial Input Timing

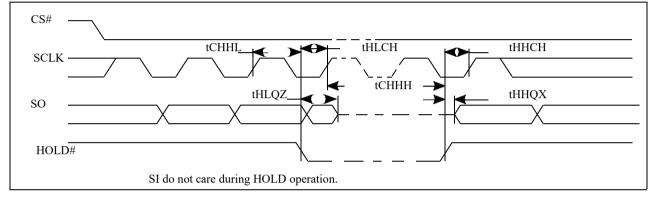




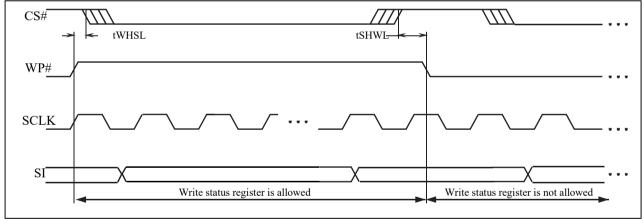
### Figure 4-5 Output Timing



### Figure 4-6 Hold Timing



### Figure 4-7 WP Timing



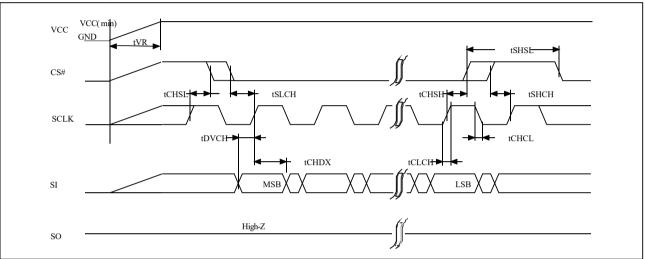


# 4.5. Operation Conditions

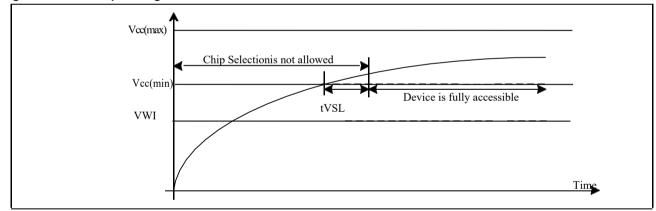
### At Device Power-Up and Power-Down

AC timing illustrated in "Figure AC Timing at Device Power-Up" and "Figure Power-Down Sequence" are for the supply voltages and the control signals at device power-up and power-down. If the timing in the figures is ignored, the device will not operate correctly.

During power-up and power-down, CS# needs to follow the voltage applied on VCC to keep the device not to be selected. The CS# can be driven low when VCC reach Vcc(min.) and wait a period of tVSL.



#### Figure 4-8 AC Timing at Device Power-Up



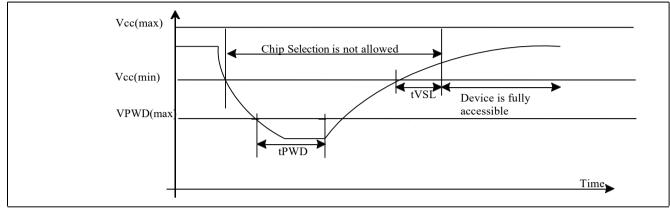
#### Figure 4-9 Power-Up Timing



### Power Up/Down and Voltage Drop

For Power-down to Power-up operation, the VCC of flash device must below VPWD for at least tPWD timing. Please check the table below for more detail.

### Figure 4-10 Power down-up Timing



Symbol	Parameter	min	max	unit
VPWD	VCC voltage needed to below VPWD for ensuring initialization will occur		1	v
tPWD	The minimum duration for ensuring initialization will occur	300		us
tVSL	VCC(min.) to device operation	70		us
tVR	VCC Rise Time	1	500000	us/V
VWI	Write Inhibit Voltage	1.45	1.55	V

# 5. Commands

# 5.1. Commands listing

# Figure 5-1 Command set

Commands	Abbr.	Code	ADR Bytes	DMY Bytes	Data Bytes	Function description
Read						
Read Array (fast)	FREAD	0Bh	3	1	1+	n bytes read out until CS# goes high
Read Array (low power)	READ	03h	3	0	1+	n bytes read out until CS# goes high
Read Dual Output	DREAD	3Bh	3	1	1+	n bytes read out by Dual output
Read 2x I/O	2READ	BBh	3	1	1+	n bytes read out by 2 x I/O
Read Quad Output	QREAD	6Bh	3	1	1+	n bytes read out by Quad output
Read 4x I/O	4READ	EBh	3	1	1+	n bytes read out by 4 x I/O
<b>Program and Erase</b>						
Page Erase	PE	81h	3	0	0	erase selected page
Sector Erase (4K bytes)	SE	20h	3	0	0	erase selected sector
Block Erase (32K bytes)	BE32	52h	3	0	0	erase selected 32K block
Block Erase (64K bytes)	BE64	D8h	3	0	0	erase selected 64K block
Chip Erase	CE	60h	0	0	0	erase whole chip
		C7h	0	0	0	erase whole chip
Page Program	PP	02h	3	0	1+	program selected page
Dual-IN Page Program	2PP	A2h	3	0	1+	program selected page by Dual input
Quad page program	QPP	32h	3	0	1+	quad input to program selected page
Program/Erase Suspend	PE S	75h	0	0	0	suspend program/erase operation
		B0h	0	0	0	suspend program/erase operation
Program/Erase Resume	PER	7Ah	0	0	0	continue program/erase operation
		30h	0	0	0	continue program/erase operation
Protection						
Write Enable	WREN	06h	0	0	0	sets the (WEL) write enable latch bit
Write Disable	WRDI	04h	0	0	0	resets the (WEL) write enable latch bit
Volatile SR Write Enable	VWREN	50h	0	0	0	Write enable for volatile status register
Security			1	1		
Erase Security Registers	ERSCUR	44h	3	0	0	Erase security registers
Program Security Registers	PRSCUR	42h	3	0	1+	Program security registers
Read Security Registers	RDSCUR	48h	3	1	1+	Read value of security register
Status Register			1			
Read Status Register	RDSR	05h	0	0	1	read out status register
	RDSR2	35h	0	0	1	Read out status register-1
Read Configure Register	RDCR	15h	0	0	1	read out configureregister
Active Status Interrupt	ASI	25h	0	1	0	Enable the active status interrupt



### Command set (Cont'd)

Commands	Abbr.	Code	ADR Bytes	DMY Bytes	Data Bytes	Functio n			
Other Commands									
Write Status Register	WRSR	01h	0	0	2	Write data to status registers			
Write Configure Register	WRCR	31h	0	0	1	Write data to configuration registers			
Reset Enable	RSTEN	66h	0	0	0	Enable reset			
Reset	RST	99h	0	0	0	Reset			
Read Manufacturer/device ID	RDID	9Fh	0	0	1 to 3	output JEDEC ID: 1-byte manufacturer ID & 2-byte device ID			
Read Manufacture ID	REMS	90h	3		1+	Read manufacturer ID/device ID data			
Dual Read Manufacture ID	DREMS	92h	3	1	1+	Dual output read manufacture/device ID			
Quad Read Manufacture ID	QREMS	94h	3	1	1+	Quad output read manufacture/device ID			
Deep Power-down	DP	B9h	0	0	0	enters deep power-down mode			
Release Deep Power-down/Read Electronic ID	RDP/RE S	ABh	3	0	1	Read electronic ID data			
Set burst length	SBL	77h	0	0	0	Set burst length			
Read SFDP	RDSFDP	5Ah				Read SFDP parameter			
Release read enhanced		FFh				Release from read enhanced			
Read unique ID	RUID	4Bh		4	1+	Read unique ID			

NOTE:

1. Dual Output data IO0 = (D6, D4, D2, D0) IO1 = (D7, D5, D3, D1)

2. Dual Input Address IO0 = A22, A20, A18, A16, A14, A12, A10, A8 A6, A4, A2, A0, M6, M4, M2, M0 IO1 = A23, A21, A19, A17, A15, A13, A11, A9 A7, A5, A3, A1, M7, M5, M3, M1

3. Quad Output Data IO0 = (D4, D0, ....) IO1 = (D5, D1, ....) IO2 = (D6, D2, ....) IO3 = (D7, D3,....)

4. Quad Input Address IO0 = A20, A16, A12, A8, A4, A0, M4, M0 IO1 = A21, A17, A13, A9, A5, A1, M5, M1 IO2 = A22, A18, A14, A10, A6, A2, M6, M2 IO3 = A23, A19, A15, A11, A7, A3, M7, M3

5. Fast Read Quad I/O Data

IO0 = (x, x, x, x, D4, D0,...) IO1 = (x, x, x, x, D5, D1,...) IO2 = (x, x, x, x, D6, D2,...) IO3 = (x, x, x, x, D7, D3,...)

6. Security Registers Address:

Security Register1: A23-A16=00H, A15-A9=0001000, A8-A0= Byte Address; Security Register2: A23-A16=00H, A15-A9=0010000, A8-A0= Byte Address; Security Register3: A23-A16=00H, A15-A9=0011000, A8-A0= Byte Address;

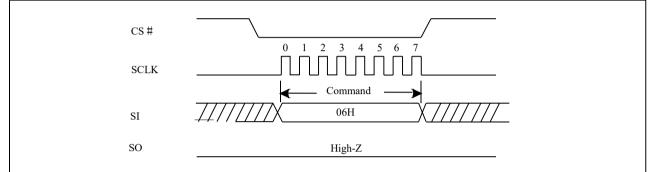


# 5.2. Write Enable (WREN)

The Write Enable (WREN) instruction is for setting Write Enable Latch (WEL) bit. For those instructions like PP,DPP,QPP, PE,SE, BE32K,BE, CE, and WRSR,ERSCUR, PRSCUR which are intended to change the device content, should be set every time after the WREN instruction setting the WEL bit.

The sequence of issuing WREN instruction is: CS# goes low $\rightarrow$  sending WREN instruction code $\rightarrow$  CS# goes high.





# 5.3. Write Disable (WRDI)

The Write Disable (WRDI) instruction is for resetting Write Enable Latch (WEL) bit.

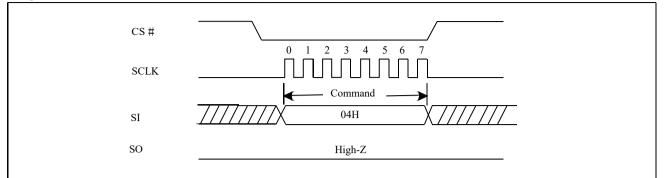
The sequence of issuing WRDI instruction is: CS# goes low $\rightarrow$  sending WRDI instruction code $\rightarrow$  CS# goes high.

The WEL bit is reset by following situations:

- Power-up
- Write Disable (WRDI) instruction completion
- Write Status Register (WRSR) instruction completion
- Page Program (PP) instruction completion
- Dual Input Page Program (DPP) instruction completion
- Quod Page Program (QPP) instruction completion
- Page Erase (PE) instruction completion
- Sector Erase (SE) instruction completion
- Block Erase (BE32K,BE) instruction completion
- Chip Erase (CE) instruction completion
- Erase Security Register (ERSCUR) instruction completion
- Program Security Register (PRSCUR) instruction completion
- Reset (RST) instruction completion



#### Figure 5-3 Write Disable (WRDI) Sequence (Command 04)

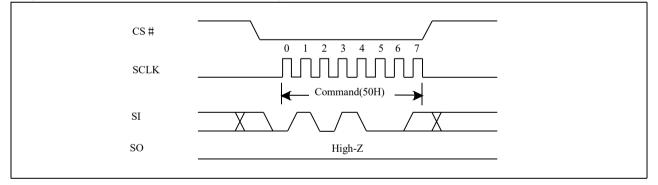


# 5.4. Write Enable for Volatile Status Register

The non-volatile Status Register bits can also be written to as volatile bits. This gives more flexibility to change the system configuration and memory protection schemes quickly without waiting for the typical non-volatile bit write cycles or affecting the endurance of the Status Register non-volatile bits. The Write Enable for Volatile Status Register command must be issued prior to a Write Status Register command. The Write Enable for Volatile Status Register command will not set the Write Enable Latch bit, it is only valid for the Write Status Register command to change the volatile Status Register bit values.

The sequence of issuing Write Enable for Volatile Status Register instruction is: CS# goes low $\rightarrow$  sending Write Enable for Volatile Status Register instruction code $\rightarrow$  CS# goes high.

#### Figure 5-4 Write Enable for Volatile Status Register Sequence (Command 50)





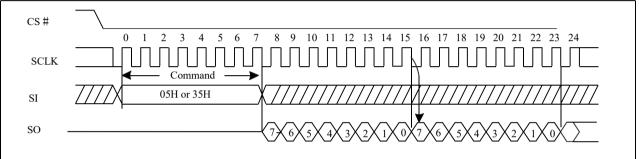
# 5.5. Read Status Register (RDSR)

The RDSR instruction is for reading Status Register Bits. The Read Status Register can be read at any time (even in program/erase/write status register condition). It is recommended to check the Write in Progress (WIP) bit before sending a new instruction when a program, erase, or write status register operation is in progress. For command code "05H", the SO will output Status Register bits S7~S0. The command code "35H", theSO will output Status Register bits S15~S8.

The sequence of issuing RDSR instruction is: CS# goes low $\rightarrow$  sending RDSR instruction code $\rightarrow$  Status Register data out on SO.

The SIO[3:1] are "don't care".

### Figure 5-5 Read Status Register (RDSR) Sequence (Command 05 or 35)



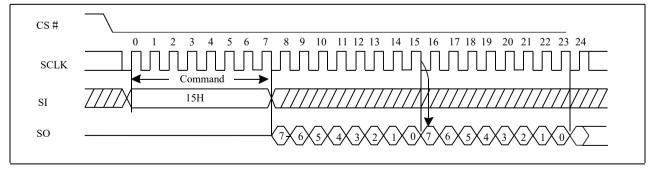
# 5.6.Read Configure Register (RDCR)

The RDCR instruction is for reading Configure Register Bits. The Read Configure Register can be read at any time (even in program/erase/write status register condition). It is recommended to check the Write in Progress (WIP) bit before sending a new instruction when a program, erase, or write status register operation is in progress.

The sequence of issuing RDCR instruction is: CS# goes low $\rightarrow$  sending RDCR instruction code $\rightarrow$  Configure Register data out on SO.

The SIO[3:1] are "don't care".

### Figure 5-6 Read Configure Register (RDCR) Sequence (Command 15)



# 5.7. Active Status Interrupt (ASI)

To simplify the readout of the WIP bit, the Active Status Interrupt command (25h) may be used. It is then not necessary to continuously read the status register, it is sufficient to monitor the value of the SO line. If the SO line is connected to an interrupt line on the host controller, the host controller may be in sleep mode until the SO line indicates that the device is ready for the next command.

The WIP bit can be read at any time, including during an internally self-timed program or erase operation. To enable the Active Status Interrupt command, the CS pin must first be asserted and the opcode of 25h must be clocked into the device. For SPI Mode0 and Mode3, at least one dummy bit has to be clocked into the device after the last bit of the opcode has been clocked in. (In most cases, this is most easily done by sending a dummy byte to the device.) The value of the SI line after the opcode is clocked in is of no significance to the operation.

The value of WIP is then output on the SO line, and is continuously updated by the device for as long as the CS pin remains asserted. Additional clocks on the SCLK pin are not required. For SPI Mode3, SCLK must keep low. If the WIP bit changes from 1 to 0 while the CS pin is asserted, the SO line will change from 1 to 0. (The WIP bit cannot change from 0 to 1 during an operation, so if the SO line already is 0, it will not change.)

Deasserting the CS pin will terminate the Active Status Interrupt operation and put the SO pin into a high-impedance state. The CS pin can be deasserted at any time and does not require that a full byte of data be read.

The sequence of issuing ASI instruction is: CS# goes low $\rightarrow$  sending ASI instruction code $\rightarrow$  WIP data out on SO.

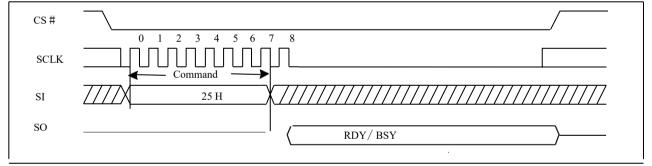


Figure 5-7 Active Status Interrupt (ASI) Sequence (Command 25)

# 5.8. Write Status Register (WRSR)

The Write Status Register (WRSR) command allows new values to be written to the Status Register. Before it can be accepted, a Write Enable (WREN) command must previously have been executed. After the Write Enable (WREN) command has been decoded and executed, the device sets the Write Enable Latch (WEL).

The Write Status Register (WRSR) command has no effect on S15, S10, S1 and S0 of the Status Register. CS# must be driven high after the eighth or sixteen bit of the data byte has been latched in. If not, the Write Status Register (WRSR) command is not executed. If CS# is driven high after eighth bit of the data byte, the CMP and QE and SRP1 bits will not change. As soon as CS# is driven high, the self-timed Write Status Register cycle (whose duration is tW) is initiated. While the Write Status Register cycle is in progress, the Status Register may still be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Write Status Register cycle, and is 0 when it is completed. When the cycle is



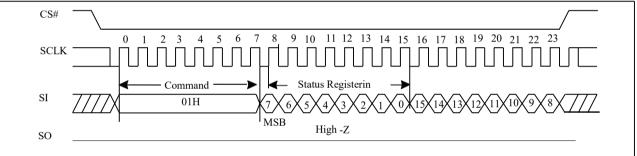
completed, the Write Enable Latch (WEL) is reset.

The Write Status Register (WRSR) command allows the user to change the values of the Block Protect (BP4, BP3, BP2, BP1, and BP0) bits, to define the size of the area that is to be treated as read-only, as defined in Table1. The Write Status Register (WRSR) command also allows the user to set or reset the Status Register Protect (SRP1 and SRP0) bits in accordance with the Write Protect (WP#) signal. The Status Register Protect (SRP1 and SRP0) bits and Write Protect (WP#) signal allow the device to be put in the Hardware Protected Mode. The Write Status Register (WRSR) command is not executed once the Hardware Protected Mode is entered.

The sequence of issuing WRSR instruction is: CS# goes low $\rightarrow$  sending WRSR instruction code $\rightarrow$  Status Register data on SI $\rightarrow$ CS# goes high.

The CS# must go high exactly at the 8 bits or 16 bits data boundary; otherwise, the instruction will be rejected and not executed. The self-timed Write Status Register cycle time (tW) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked during the Write Status Register cycle is in progress. The WIP sets 1 during the tW timing, and sets 0 when Write Status Register Cycle is completed, and the Write Enable Latch (WEL) bit is reset.

### Figure 5-8 Write Status Register (WRSR) Sequence (Command 01)



# 5.9. Write Configure Register (WRCR)

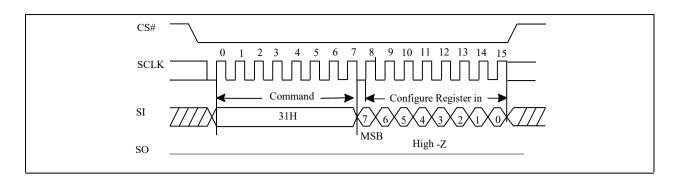
The Write Configure Register (WRCR) command allows new values to be written to the Configure Register. Before it can be accepted, a Write Enable (WREN) command must previously have been executed. After the Write Enable (WREN) command has been decoded and executed, the device sets the Write Enable Latch (WEL).

The sequence of issuing WRCR instruction is: CS# goes low $\rightarrow$  sending WRCR instruction code $\rightarrow$  Configure Register data on SI $\rightarrow$ CS# goes high.

The CS# must go high exactly at the 8 bits data boundary; otherwise, the instruction will be rejected and not executed. The self-timed Write Status Register cycle time (tW) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked during the Write Status Register cycle is in progress. The WIP sets 1 during the tW timing, and sets 0 when Write Configure Register Cycle is completed, and the Write Enable Latch (WEL) bit is reset.

#### Figure 5-9 Write Configure Register (WRCR) Sequence (Command 01)

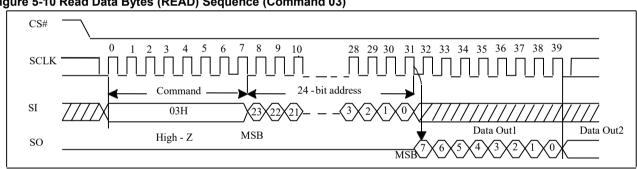




# 5.10. Read Data Bytes (READ)

The read instruction is for reading data out. The address is latched on rising edge of SCLK, and data shifts out on the falling edge of SCLK at a maximum frequency fR. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single READ instruction. The address counter rolls over to 0 when the highest address has been reached.

The sequence of issuing READ instruction is: CS# goes low $\rightarrow$  sending READ instruction code $\rightarrow$  3-byte address on SI $\rightarrow$  data out on SO $\rightarrow$  to end READ operation can use CS# to high at any time during data out.



### Figure 5-10 Read Data Bytes (READ) Sequence (Command 03)

# 5.11. Read Data Bytes at Higher Speed (FAST READ)

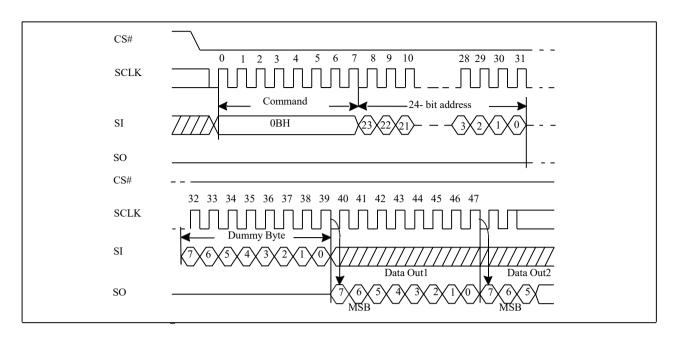
The FAST\_READ instruction is for quickly reading data out. The address is latched on rising edge of SCLK, and data of each bit shifts out on the falling edge of SCLK at a maximum frequency fC. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single FAST\_READ instruction. The address counter rolls over to 0 when the highest address has been reached.

The issuing FAST READ instruction CS#  $low \rightarrow sending$ sequence of is: goes  $code \rightarrow 3$ -byte address on SI $\rightarrow$  1-dummy byte address on SI $\rightarrow$ data out on SO $\rightarrow$ FAST READ instruction to end FAST READ operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, FAST READ instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.

### Figure 5-11 Read at Higher Speed (FAST READ) Sequence (Command 0B)







# 5.12. Dual Read Mode (DREAD)

The DREAD instruction enable double throughput of Serial NOR Flash in read mode. The address is latched on rising edge of SCLK, and data of every two bits (interleave on 2 I/O pins) shift out on the falling edge of SCLK at a maximum frequency fT. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single DREAD instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing DREAD instruction, the following data out will perform as 2-bit instead of previous 1-bit.

The sequence of issuing DREAD instruction is: CS# goes low  $\rightarrow$  sending DREAD instruction  $\rightarrow$  3-byte address on SI  $\rightarrow$  8-bit dummy cycle  $\rightarrow$  data out interleave on SIO1 & SIO0  $\rightarrow$  to end DREAD operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, DREAD instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.

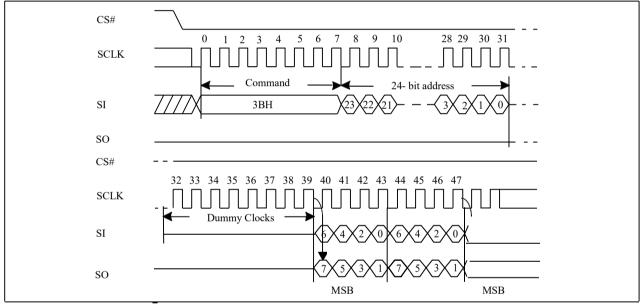


Figure 5-12 Dual Read Mode Sequence (Command 3B)



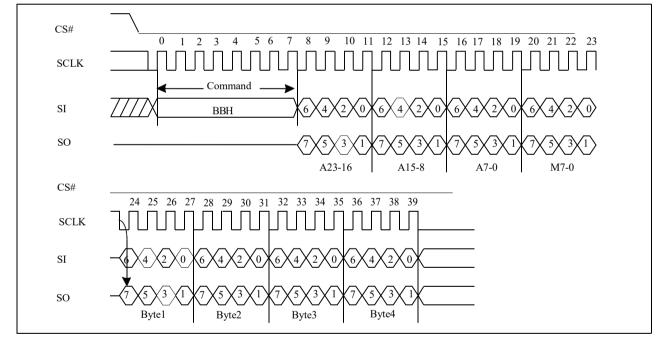
# 5.13.2 X IO Read Mode (2READ)

The 2READ instruction enables Double Transfer Rate of Serial NOR Flash in read mode. The address is latched on rising edge of SCLK, and data of every two bits (interleave on 2 I/O pins) shift out on the falling edge of SCLK at a maximum frequency fT. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single 2READ instruction. The address counter rolls over to 0 when the highest address has been reached.

Once writing 2READ instruction, the following address/dummy/data out will perform as 2-bit instead of previous 1-bit.

The sequence of issuing 2READ instruction is: CS# goes low $\rightarrow$  sending 2READ instruction $\rightarrow$  24-bit address interleave on SIO1 & SIO0 $\rightarrow$  8-bit dummy cycle on SIO1 & SIO0 $\rightarrow$  data out interleave on SIO1 & SIO0 $\rightarrow$  to end 2READ operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, 2READ instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.



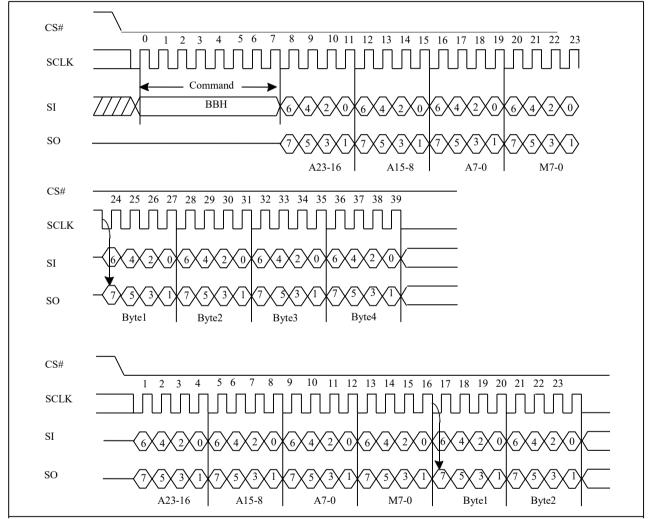
#### Figure 5-13 2 X IO Read Mode Sequence (Command BB M5-4 ≠ (1,0))

Zetta

# 5.14.2 X IO Read Performer Enhance Mode

"BBh" command supports 2 X IO Performance Enhance Mode which can further reduce command overhead through setting the "Continuous Read Mode" bits (M7-0) after the input 3-byte address (A23-A0). If the "Continuous Read Mode" bits (M5-4) = (1, 0), then the next 2 X IO Read command (after CS# is raised and then lowered) does not require the BBH command code.

If the "Continuous Read Mode" bits (M5-4) do not equal (1, 0), the next command requires the first BBH command code, thus returning to normal operation. A "Continuous Read Mode" Reset command can be used to reset (M5-4) before issuing normal command.





Note: 2 X IO Read Performance Enhance Mode, if M5-4 = 1, 0. If not using performance enhance recommend to set M5-4  $\neq$  1, 0.

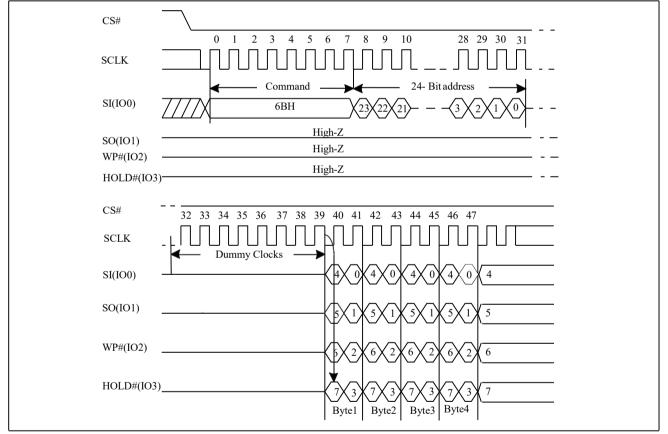


# 5.15. Quad Read Mode (QREAD)

The QREAD instruction enable quad throughput of Serial NOR Flash in read mode. A Quad Enable (QE) bit of status Register must be set to "1" before sending the QREAD instruction. The address is latched on rising edge of SCLK, and data of every four bits (interleave on 4 I/O pins) shift out on the falling edge of SCLK at a maximum frequency fQ. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single QREAD instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing QREAD instruction, the following data out will perform as 4-bit instead of previous 1-bit.

The sequence of issuing QREAD instruction is: CS# goes low  $\rightarrow$  sending QREAD instruction  $\rightarrow$  3-byte address on SI  $\rightarrow$  8-bit dummy cycle  $\rightarrow$  data out interleave on SIO3, SIO2, SIO1 & SIO0  $\rightarrow$  to end QREAD operation can use CS# to high at any time during data out.

While Program/Erase/Write Status Register cycle is in progress, QREAD instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.



#### Figure 5-15 Quad Read Mode Sequence (Command 6B)



## 5.16.4 X IO Read Mode (4READ)

The 4READ instruction enable quad throughput of Serial NOR Flash in read mode. A Quad Enable (QE) bit of status Register must be set to "1" before sending the 4READ instruction. The address is latched on rising edge of SCLK, and data of every four bits (interleave on 4 I/O pins) shift out on the falling edge of SCLK at a maximum frequency fQ. The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single 4READ instruction. The address has been reached. Once writing 4READ instruction, the following address/dummy/data out will perform as 4-bit instead of previous 1-bit.

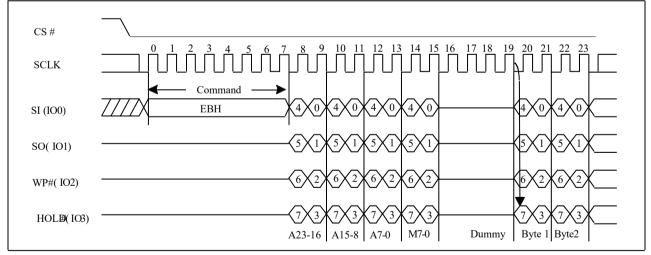
The sequence of issuing 4READ instruction is: CS# goes low  $\rightarrow$  sending 4READ instruction  $\rightarrow$  24-bit address interleave on SIO3, SIO2, SIO1 & SIO0  $\rightarrow$  2+4 dummy cycles  $\rightarrow$  data out interleave on SIO3, SIO2, SIO1 & SIO0  $\rightarrow$  to end 4READ operation can use CS# to high at any time during data out.

Another sequence of issuing 4READ instruction especially useful in random access is: CS# goes low  $\rightarrow$  sending 4READ instruction  $\rightarrow$  3-bytes address interleave on SIO3, SIO2, SIO1 & SIO0  $\rightarrow$  "Continuous Read Mode" byte M[7:0]  $\rightarrow$  4 dummy cycles  $\rightarrow$  data out still CS# goes high  $\rightarrow$  CS# goes low(reduce 4 Read instruction)

→24-bit random access address.

In the performance-enhancing mode, the "Continuous Read Mode" bits M[5:4] = (1,0) can make this mode continue and reduce the next 4READ instruction. Once  $M[5:4] \neq (1,0)$  and afterwards CS# is raised and then lowered, the system then will escape from performance enhance mode and return to normal operation. A "Continuous Read Mode" Reset command can be used to reset (M5-4) before issuing normal command

While Program/Erase/Write Status Register cycle is in progress, 4READ instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.



#### Figure 5-16 4 X IO Read Mode Sequence (Command EB M5-4 ≠ (1,0))

Note:

- 1. Hi-impedance is inhibited for the two clock cycles.
- 2. M[5-4] = (1,0) is inhibited.

Zetta

## 5.17.4 X IO Read Performance Enhance

"EBh" command supports 4 X IO Performance Enhance Mode which can further reduce command overhead through setting the "Continuous Read Mode" bits (M7-0) after the input 3-byte address (A23-A0). If the "Continuous Read Mode" bits (M5-4) = (1, 0), then the next 4 X IO Read command (after CS# is raised and then lowered) does not require the EBH command code.

If the "Continuous Read Mode" bits (M5-4) do not equal (1, 0), the next command requires the first EBH command code, thus returning to normal operation. A "Continuous Read Mode" Reset command can be used to reset (M5-4) before issuing normal command.

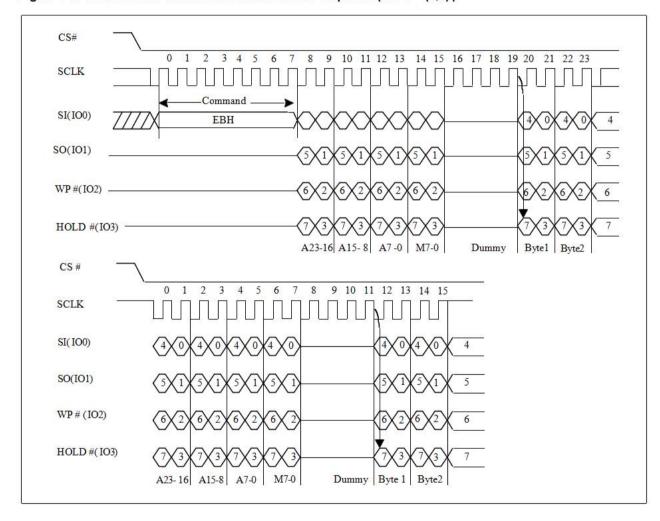


Figure 5-17 4 x I/O Read Performance Enhance Mode Sequence (M5-4 = (1,0))

Note: 1. 4 X IO Read Performance Enhance Mode, if M5-4 = 1, 0. If not using performance enhance



## 5.18. Burst Read

The Set Burst with Wrap command is used in conjunction with "4 X IO Read" command to access a fixed length of 8/16/32/64-byte section within a 256-byte page, in standard SPI mode.

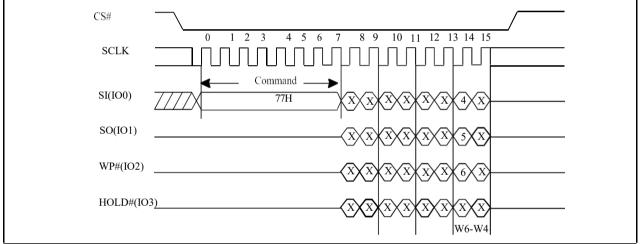
The Set Burst with Wrap command sequence: CS# goes low  $\rightarrow$  Send Set Burst with Wrap command  $\rightarrow$  Send 24 dummy bits $\rightarrow$  Send 8 bits "Wrap bits"  $\rightarrow$  CS# goes high.

	W4	l=0	0 W4=1 (default)		
W6,W5	Wrap Aroud	Wrap Length	Wrap Aroud	Wrap Length	
0,0	Yes	8-byte	No	N/A	
0,1	Yes	16-byte	No	N/A	
1,0	Yes	32-byte	No N/A		
1,1	Yes	64-byte	No	N/A	

If the W6-W4 bits are set by the Set Burst with Wrap command, all the following "4 X IO Read" command will use the W6-W4 setting to access the 8/16/32/64-byte section within any page. To exit the "Wrap Around" function and return to normal read operation, another Set Burst with Wrap command should be issued to set W4=1.



Figure 5-18 Burst Read (SBL) Sequence (Command 77)



## 5.19. Page Erase (PE)

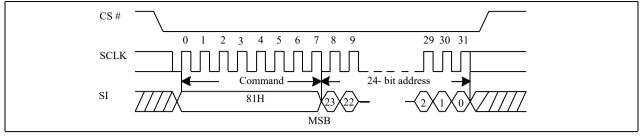
The Page Erase (PE) instruction is for erasing the data of the chosen Page to be "1". A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Page Erase (PE).

To perform a Page Erase with the standard page size (256 bytes), an opcode of 81h must be clocked into the device followed by three address bytes comprised of 2 page address bytes that specify the page in the main memory to be erased, and 1 dummy byte.

The sequence of issuing PE instruction is: CS# goes low  $\rightarrow$  sending PE instruction code $\rightarrow$  3-byte address on SI  $\rightarrow$  CS# goes high



#### Figure 5-19 Page Erase Sequence (Command 81)



## 5.20. Sector Erase (SE)

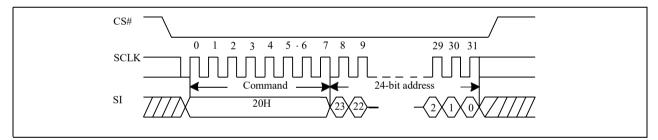
The Sector Erase (SE) instruction is for erasing the data of the chosen sector to be "1". A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Sector Erase (SE). Any address of the sector is a valid address for Sector Erase (SE) instruction. The CS# must go high exactly at the byte boundary (the latest eighth of address byte been latched-in); otherwise, the instruction will be rejected and not executed.

Address bits [Am-A12] (Am is the most significant address) select the sector address.

The sequence of issuing SE instruction is: CS# goes low  $\rightarrow$  sending SE instruction code $\rightarrow$  3-byte address on SI  $\rightarrow$  CS# goes high.

The SIO[3:1] are don't care.

#### Figure 5-20 Sector Erase (SE) Sequence (Command 20)



## 5.21. Block Erase (BE32K)

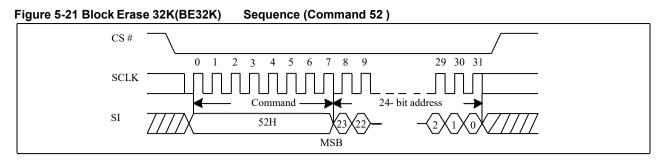
The Block Erase (BE32K) instruction is for erasing the data of the chosen block to be "1". The instruction is used for 32K-byte block erase operation. A Write Enable (WREN) instruction must be executed to set the Write Enable Latch (WEL) bit before sending the Block Erase (BE32K). Any address of the block is a valid address for Block Erase (BE32K) instruction. The CS# must go high exactly at the byte boundary (the least significant bit of address byte has been latched-in); otherwise, the instruction will be rejected and not executed.

The sequence of issuing BE32K instruction is: CS# goes low  $\rightarrow$  sending BE32K instruction code  $\rightarrow$  3-byte address on SI  $\rightarrow$  CS# goes high.

The SIO[3:1] are don't care.

The self-timed Block Erase Cycle time (tBE32K) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked while the Block Erase cycle is in progress. The WIP sets during the tBE32K timing, and clears when Block Erase Cycle is completed, and the Write Enable Latch (WEL) bit is cleared. If the block is protected by BP4, BP3, BP2, BP1,BP0 bits, the array data will be protected (no change) and the WEL bit still be reset.





## 5.22. Block Erase (BE)

The Block Erase (BE) instruction is for erasing the data of the chosen block to be "1". The instruction is used for 64K-byte block erase operation. A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Block Erase (BE). Any address of the block is a valid address for Block Erase (BE) instruction. The CS# must go high exactly at the byte boundary (the latest eighth of address byte been latched-in); otherwise, the instruction will be rejected and not executed.

The sequence of issuing BE instruction is: CS# goes low $\rightarrow$  sending BE instruction code $\rightarrow$  3-byte address on SI $\rightarrow$ CS# goes high.

The SIO[3:1] are "don't care".

The self-timed Block Erase Cycle time (tBE) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked during the Block Erase cycle is in progress. The WIP sets 1 during the tBE timing, and sets 0 when Block Erase Cycle is completed, and the Write Enable Latch (WEL) bit is reset. If the block is protected by BP4, BP3, BP2, BP1, BP0 bits, the Block Erase (BE) instruction will not be executed on the block.

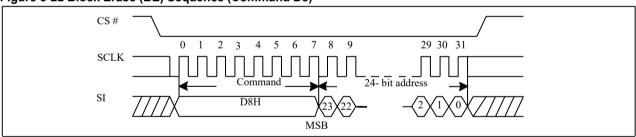


Figure 5-22 Block Erase (BE) Sequence (Command D8)

## 5.23. Chip Erase (CE)

The Chip Erase (CE) instruction is for erasing the data of the whole chip to be "1". A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Chip Erase (CE). The CS# must go high exactly at the byte boundary (the latest eighth of address byte been latched-in); otherwise, the instruction will be rejected and not executed.

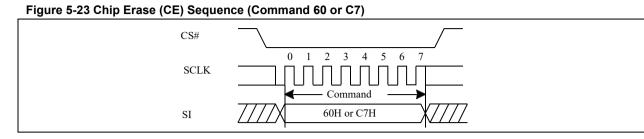
The sequence of issuing CE instruction is: CS# goes low $\rightarrow$  sending CE instruction code $\rightarrow$  CS# goes high.

The SIO[3:1] are "don't care".

The self-timed Chip Erase Cycle time (tCE) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked during the Chip Erase cycle is in progress. The WIP sets 1 during the tCE timing, and sets 0 when Chip Erase Cycle is completed, and the Write Enable Latch (WEL) bit is reset. If



the chip is protected by BP4,BP3, BP2, BP1, BP0 bits, the Chip Erase (CE) instruction will not be executed. It will be only executed when all Block Protect(BP4, BP3, BP2, BP1, BP0) are set to "None protected".



## 5.24. Page Program (PP)

The Page Program (PP) instruction is for programming the memory to be "0". A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Page Program (PP). The device programs only the last 256 data bytes sent to the device. If the entire 256 data bytes are going to be programmed, A7-A0 (The eight least significant address bits) should be set to 0. If the eight least significant address bits (A7-A0) are not all 0, all transmitted data going beyond the end of the current page are programmed from the start address of the same page (from the address A7-A0 are all 0). If more than 256 bytes are sent to the device, the data of the last 256-byte is programmed at the request page and previous data will be disregarded. If less than 256 bytes are sent to the device, the data is programmed at the requested address of the page without effect on other address of the same page.

The sequence of issuing PP instruction is: CS# goes low $\rightarrow$  sending PP instruction code $\rightarrow$  3-byte address on SI $\rightarrow$  at least 1-byte on data on SI $\rightarrow$  CS# goes high.

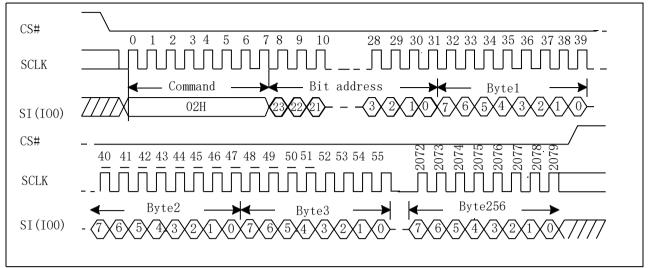
The CS# must be kept low during the whole Page Program cycle; The CS# must go high exactly at the byte boundary (the latest eighth bit of data being latched in), otherwise the instruction will be rejected and will not be executed.

The self-timed Page Program Cycle time (tPP) is initiated as soon as Chip Select (CS#) goes high. The Write in Progress (WIP) bit still can be checked during the Page Program cycle is in progress. The WIP sets 1 during the tPP timing, and sets 0 when Page Program Cycle is completed, and the Write Enable Latch (WEL) bit is reset. If the page is protected by BP4, BP3, BP2, BP1, BP0 bits, the Page Program (PP) instruction will not be executed.

The SIO[3:1] are "don't care".





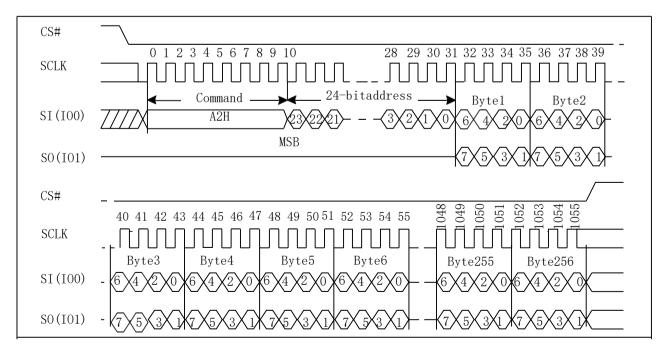


#### 5.25. Dual Input Page Program (DPP)

The Dual Input Page Program (DPP) instruction is similar to the standard Page Program command and can be used to program anywhere from a single byte of data up to 256 bytes of data into previously erased memory locations. The Dual-Input Page Program command allows two bits of data to be clocked into the device on every clock cycle rather than justone.

A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit before sending the Dual Input Page Program (DPP). The Dual Input Page Programming takes two pins: SIO0, SIO1 as data input, which can improve programmer performance and the effectiveness of application. The other function descriptions are as same as standard page program.

The sequence of issuing DPP instruction is: CS# goes low $\rightarrow$  sending DPP instruction code $\rightarrow$  3-byte address on SI $\rightarrow$ at least 1-byte on data on SIO[1:0] $\rightarrow$  CS# goes high.



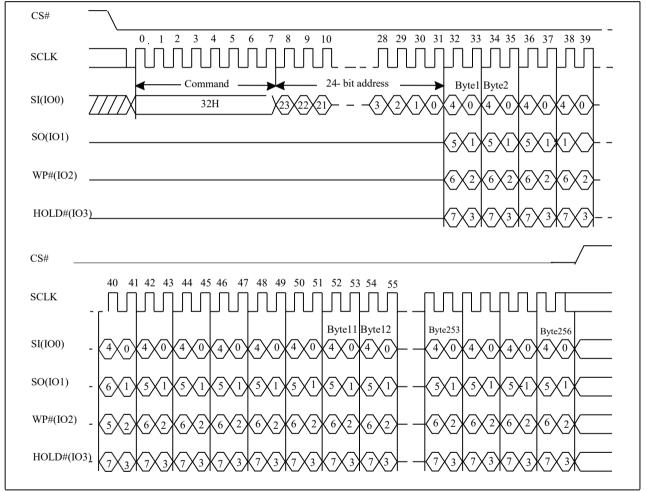
#### Figure 5-25 Page Program (DPP) Sequence (Command A2)



## 5.26. Quad Page Program (QPP)

The Quad Page Program (QPP) instruction is for programming the memory to be "0". A Write Enable (WREN) instruction must execute to set the Write Enable Latch (WEL) bit and Quad Enable (QE) bit must be set to "1" before sending the Quad Page Program (QPP). The Quad Page Programming takes four pins: SIO0, SIO1, SIO2, and SIO3 as data input, which can improve programmer performance and the effectiveness of application. The QPP operation frequency supports as fast as fQPP. The other function descriptions are as same as standard page program.

The sequence of issuing QPP instructions:CS# goes low  $\rightarrow$  sending QPP instruction code $\rightarrow$  3-byte address on SI $\rightarrow$ at least 1-byte on data on SIO[1:0] $\rightarrow$  CS# goes high.



#### Figure 5-26 Page Program (QPP) Sequence (Command 32)



## 5.27. Erase Security Registers (ERSCUR)

The product provides three512-byte Security Registers which can be erased and programmed individually. These registers may be used by the system manufacturers to store security and other important information separately from the main memory array.

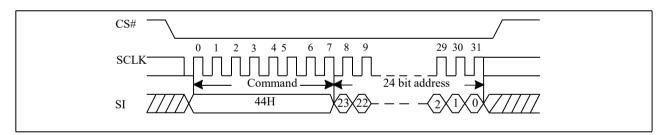
The Erase Security Registers command is similar to Sector/Block Erase command, the instruction is used for 512-byte erase operation. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL)bit.

The Erase Security Registers command sequence: CS# goes low  $\rightarrow$  sending ERSCUR instruction  $\rightarrow$  sending 24 bit address  $\rightarrow$  CS# goes high.

CS# must be driven high after the eighth bit of the command code has been latched in; otherwise the Erase Security Registers command is not executed. As soon as CS# is driven high, the self-timed Erase Security Registers cycle (whose duration is tSE) is initiated. While the Erase Security Registers cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Erase Security Registers cycle, and is 0 when it is completed. The Security Registers Lock Bit (LB3-1) in the Status Register can be used to OTP protect the security registers. Once the LB bit is set to 1, the Security Registers will be permanently locked; the Erase Security Registers command will

Address	A23-16	A15-12	A11-9	A8-0
Security Register #1	00H	0001	000	Don't care
Security Register #2	00H	0010	000	Don't care
Security Register #3	00H	0011	000	Don't care

#### Figure 5-27 Erase Security Registers (ERSCUR) Sequence (Command 44)





## 5.28. Program Security Registers (PRSCUR)

The Program Security Registers command is similar to the Page Program command. It allows from 1 to 512bytes Security Registers data to be programmed. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Program Security Registers command.

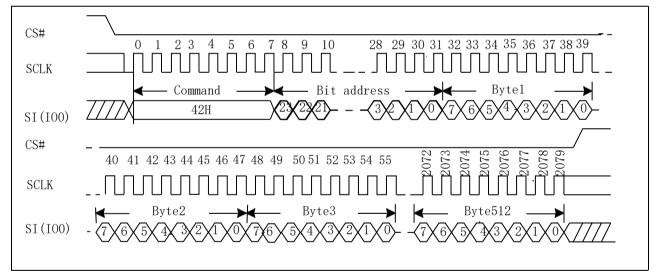
The Program Security Registers command sequence: CS# goes low  $\rightarrow$  sending PRSCUR instruction  $\rightarrow$  sending 24 bit address  $\rightarrow$  sending at least one byte data  $\rightarrow$  CS# goes high.

As soon as CS# is driven high, the self-timed Program Security Registers cycle (whose duration is tPP) is initiated. While the Program Security Registers cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Program Security Registers cycle, and is 0 when it is completed.

If the Security Registers Lock Bit (LB3-1) is set to 1, the Security Registers will be permanently locked. Program Security Registers command will be ignored.

Address	A23-16	A15-12	A5-9	A8-0
Security Register #1	00H	0001	000	Byte Address
Security Register #2	00H	0010	000	Byte Address
Security Register #3	00H	0011	000	Byte Address

Figure 5-28 Program Security Registers (PRSCUR) Sequence (Command 42)



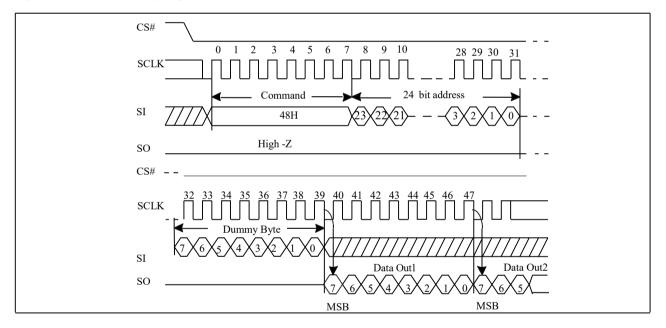
## 5.29. Read Security Registers (RDSCUR)

The Read Security Registers command is similar to Fast Read command. The command is followed by a 3-byte address (A23-A0) and a dummy byte, each bit being latched-in during the rising edge of SCLK. Then the memory content, at that address, is shifted out on SO, each bit being shifted out, at a Max frequency fC, during the falling edge of SCLK. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. Once the A8-A0 address reaches the last byte of the register (Byte 1FFH), it will reset to 000H, the command is completed by driving CS# high.

The sequence of issuing RDSCUR instruction is : CS# goes low  $\rightarrow$  sending RDSCUR instruction  $\rightarrow$  sending 24 bit address  $\rightarrow$  8 bit dummy byte  $\rightarrow$  Security Register data out on SO  $\rightarrow$  CS# goes high.

Address	A23-16	A15-12	A5-9	A8-0
Security Register #1	00H	0001	000	Byte Address
Security Register #2	00H	0010	000	Byte Address
Security Register #3	00H	0011	000	Byte Address

Figure 5-29 Read Security Registers (RDSCUR) Sequence (Command 48)





#### 5.30. Deep Power-down (DP)

The Deep Power-down (DP) instruction is for setting the device on the minimizing the power consumption (to entering the Deep Power-down mode), the standby current is reduced from ISB1 to ISB2). The Deep

Power-down mode requires the Deep Power-down (DP) instruction to enter, during the Deep Power-down mode, the device is not active and all Write/Program/Erase instruction are ignored. When CS# goes high, it's only in standby mode not deep power-down mode. It's different from Standby mode.

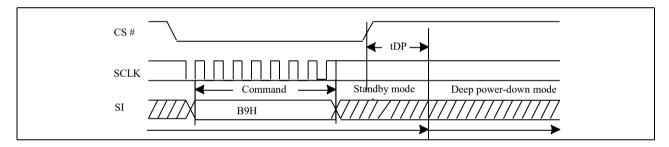
The sequence of issuing DP instruction is: CS# goes low $\rightarrow$  sending DP instruction code $\rightarrow$  CS# goes high.

Once the DP instruction is set, all instruction will be ignored except the Release from Deep Power-down mode (RDP) and Read Electronic Signature (RES) instruction. (RES instruction to allow the ID been read out).

When Power- down, the deep power-down mode automatically stops, and when power-up, the device automatically is in standby mode. For RDP instruction the CS# musOnce the DP instruction is set, all instruction will be ignored except the Release from Deep Power-down mode (RDP) and Read Electronic Signature (RES) instruction. (RES instruction to allow the ID been read out).

t go high exactly at the byte boundary (the latest eighth bit of instruction code been latched-in); otherwise, the instruction will not be executed. As soon as Chip Select (CS#) goes high, a delay of tDP is required before entering the Deep Power-down mode and reducing the current to ISB2.

#### Figure 5-30 Deep Power-down (DP) Sequence (Command B9)





#### 5.31. Release form Deep Power-Down (RDP), Read Electronic Signature (RES)

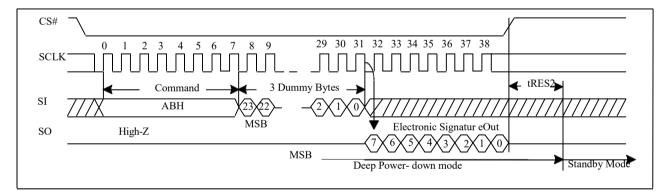
The Release from Deep Power-down (RDP) instruction is terminated by driving Chip Select (CS#) High. When Chip Select (CS#) is driven high, the device is put in the Stand-by Power mode. If the device was not previously in the Deep Power-down mode, the transition to the Stand-by Power mode is immediate. If the device was previously in the Deep Power-down mode, though, the transition to the Stand-by Power mode is delayed by tRES2, and Chip Select (CS#) must remain High for at least tRES2(max). Once in the

Stand-by Power mode, the device waits to be selected, so that it can receive, decode and execute instructions.

RES instruction is for reading out the old style of 8-bit Electronic Signature, whose values are shown as table of ID Definitions. This is not the same as RDID instruction. It is not recommended to use for new design. For new design, please use RDID instruction.Even in Deep power-down mode, the RDP and RES are also allowed to be executed, only except the device is in progress of program/erase/write cycle; there's no effect on the current program/erase/ write cycle in progress.

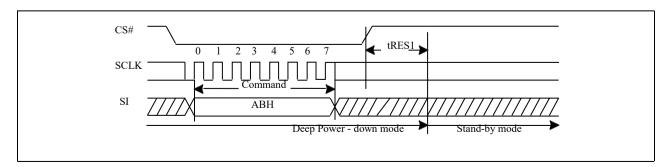
The RES instruction is ended by CS# goes high after the ID been read out at least once. The ID outputs repeatedly if continuously send the additional clock cycles on SCLK while CS# is at low. If the device was not previously in Deep Power-down mode, the device transition to standby mode is immediate. If the device was previously in Deep Power-down mode, there's a delay of tRES2 to transit to standby mode, and CS# must remain to high at least tRES2 (max). Once in the standby mode, the device waits to be selected, so it can be receive, decode, and execute instruction.

The RDP instruction is for releasing from Deep Power-Down Mode.



#### Figure 5-31 Read Electronic Signature (RES) Sequence (Command AB)

#### Figure 5-32 Release from Deep Power-down (RDP) Sequence (Command AB)





## 5.32. Read Electronic Manufacturer ID & Device ID (REMS)

The REMS instruction returns both the JEDEC assigned manufacturer ID and the device ID. The Device ID values are listed in "Table ID Definitions".

The REMS instruction is initiated by driving the CS# pin low and sending the instruction code "90h" followed by two dummy bytes and one address byte (A7~A0). After which the manufacturer ID for Zetta and the device ID are shifted out on the falling edge of SCLK with the most significant bit (MSB) first. If the least significant bit (LSB) of the address byte is 0b, the manufacturer ID will be output first, followed by the device ID. If the least significant bit (LSB) of the address byte is 1b, then the device ID will be output first, followed by the manufacturer ID. While CS# is low, the manufacturer and device IDs can be read continuously, alternating from one to the other. The instruction is completed by driving CS# high.

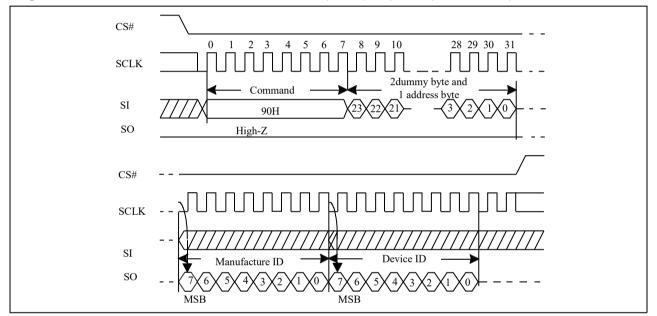


Figure 5-32 Read Electronic Manufacturer & Device ID (REMS) Sequence (Command 90)

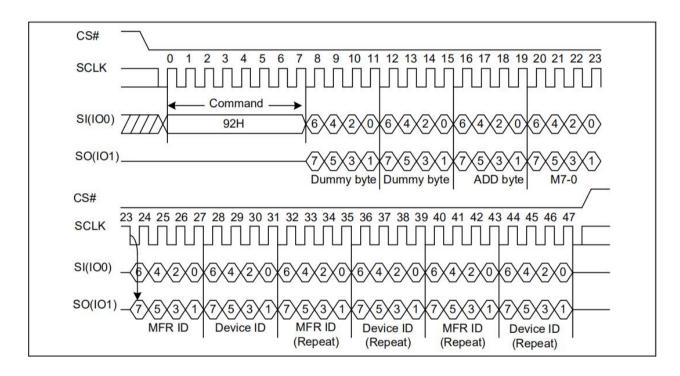


## 5.33. Dual I/O Read Electronic Manufacturer ID & Device ID (DREMS)

The DREMS instruction is similar to the REMS command and returns the JEDEC assigned manufacturer ID which takes two pins: SIO0, SIO1 as address input and ID output I/O

The instruction is initiated by driving the CS# pin low and shift the instruction code "92h" followed by two dummy bytes and one bytes address (A7~A0). , 8-bit "Continuous Read Mode" bits (M7-0) .After which, the Manufacturer ID for Zetta and the Device ID are shifted out on the falling edge of SCLK with most significant bit (MSB) first. If the least significant bit (LSB) of the one-byte address is initially set to 1b, then the device ID will be read first and then followed by the Manufacturer ID. The Manufacturer and Device IDs can be read continuously, alternating from one to the other. The instruction is completed by driving CS# high.

```
Figure 5-33 DUAL I/O Read Electronic Manufacturer & Device ID (DREMS) Sequence (Command 92)
```



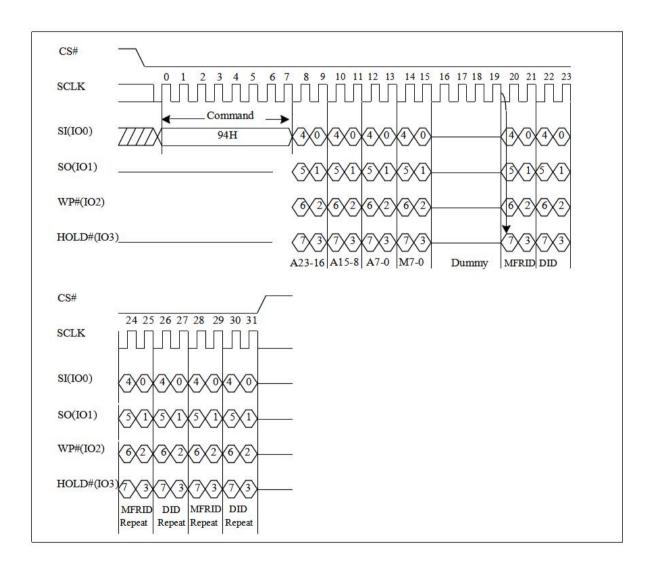


## 5.34. Quad I/O Read Electronic Manufacturer ID & Device ID (QREMS)

The QREMS instruction is similar to the REMS command and returns the JEDEC assigned manufacturer ID which takes four pins: SIO0, SIO1,SIO2,SIO3 as address input and ID output I/O

The instruction is initiated by driving the CS# pin low and shift the instruction code "94h" followed by two dummy bytes and one bytes address (A7~A0). 8-bit "Continuous Read Mode" bits (M7-0) and then two dummy bytes. After which, the Manufacturer ID for Zetta and the Device ID are shifted out on the falling edge of SCLK with most significant bit (MSB) first. If the least significant bit (LSB) of the one-byte address is initially set to 1b, then the device ID will be read first and then followed by the Manufacturer ID. The Manufacturer and Device IDs can be read continuously, alternating from one to the other. The instruction is completed by driving CS# high.

#### Figure 5-34 QUAD I/O Read Electronic Manufacturer & Device ID (QREMS) Sequence (Command 94)



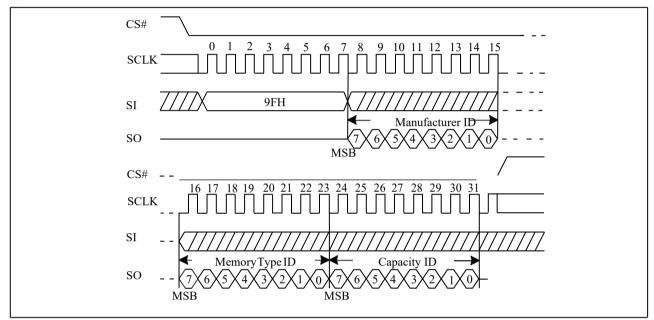


## 5.35. Read Identification (RDID)

The RDID instruction is for reading the manufacturer ID of 1-byte and followed by Device ID of 2-byte. The Zetta Manufacturer ID and Device ID are list as "as "Table . ID Definitions".

The sequence of issuing RDID instruction is: CS# goes low $\rightarrow$  sending RDID instruction code  $\rightarrow$  24-bits ID data out on SO $\rightarrow$  to end RDID operation can use CS# to high at any time during data out.

While Program/Erase operation is in progress, it will not decode the RDID instruction, so there's no effect on the cycle of program/erase operation which is currently in progress. When CS# goes high, the device is at standby stage.



#### Figure 5-35 Read Identification(RDID) Sequence (Command 9F)

#### Table ID Definitions

	RDID	manufacturer ID	memory type	memory density	
	command	BA	15		
ZD25WQ16B	RES	electronic ID			
ZD25WQ10B	command	14			
	REMS	manufacturer ID device ID			
	command	B/	4	14	

#### 5.36. Program/Erase Suspend/Resume

The Suspend instruction interrupts a Page Program, Sector Erase, or Block Erase operation to allow access to the memory array. After the program or erase operation has entered the suspended state, the memory array can be read except for the page being programmed or the sector or block being erased.

riou de moment i mane à l'regram et Erace e perutente eucependeu				
Suspended Operation	Readable Region of Memory Array			
Page Program	All but the Page being programmed			
Page Erase	All but the Page being erased			
Sector Erase(4KB)	All but the 4KB Sector being erased			
Block Erase(32KB)	All but the 32KB Block being erased			
Block Erase(64KB)	All but the 64KB Block being erased			

#### Readable Area of Memory While a Program or Erase Operation is Suspended



When the Serial NOR Flash receives the Suspend instruction, there is a latency of tPSL or tESL before the Write Enable Latch (WEL) bit clears to "0" and the SUS2 or SUS1 sets to "1", after which the device is ready to accept one of the commands listed in "Table Acceptable Commands During Program/Erase Suspend after tPSL/tESL" (e.g. FAST READ). Refer to " AC Characteristics" for tPSL and tESL timings. "Table Acceptable Commands During Suspend (tPSL/tESL not required)" lists the commands for which the tPSL and tESL latencies do not apply. For example, RDSR, RDSCUR, RSTEN, and RST can be issued at any time after the Suspend instruction.

Status Register bit 15 (SUS2) and bit 10 (SUS1) can be read to check the suspend status. The SUS2 (Program Suspend Bit) sets to "1" when a program operation is suspended. The SUS1 (Erase Suspend Bit) sets to "1" when an erase operation is suspended. The SUS2 or SUS1 clears to "0" when the program or erase operation is resumed.

Command name	Command Code	Suspend Type	
		Program Suspend	Erase Suspend
READ	03H	•	•
FAST READ	0BH	•	•
DREAD	3BH	•	•
QREAD	6BH	•	•
2READ	BBH	•	•
4READ	EBH	•	•
RDSFDP	5AH	•	•
RDID	9FH	•	•
REMS	90H	•	•
DREMS	92H	•	•
QREMS	94H	•	•
RDSCUR	48H	•	•
SBL	77H	•	•
WREN	06H		•
RESUME	7AH OR 30H	•	•
PP	02H		•
DPP	A2H		•
QPP	32H		•

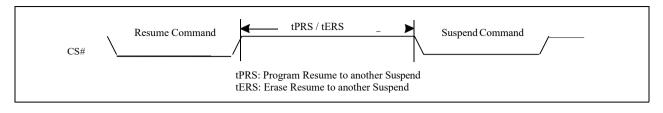
#### Acceptable Commands During Program/Erase Suspend after tPSL/tESL

#### Acceptable Commands During Suspend (tPSL/tESL not required)

Command name	Command Code	Suspend Type		
		Program Suspend	Erase Suspend	
WRDI	04H	•	•	
RDSR	05H	•	•	
RDSR2	35H	•	•	
ASI	25H	•	•	
RES	ABH	•	•	
RSTEN	66H	•	•	
RST	99H	•	•	
NOP	00H	•	•	



#### Figure 5-36 Resume to Suspend Latency

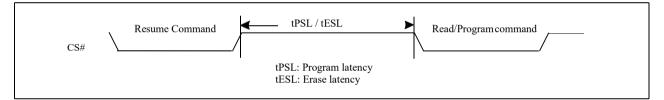


## 5.37. Erase Suspend to Program

The "Erase Suspend to Program" feature allows Page Programming while an erase operation is suspended. Page Programming is permitted in any unprotected memory except within the sector of a suspended Sector Erase operation or within the block of a suspended Block Erase operation. The Write Enable (WREN) instruction must be issued before any Page Program instruction.

A Page Program operation initiated within a suspended erase cannot itself be suspended and must be allowed to finish before the suspended erase can be resumed. The Status Register can be polled to determine the status of the Page Program operation. The WEL and WIP bits of the Status Register will remain "1" while the Page Program operation is in progress and will both clear to "0" when the Page Program operation completes.

#### Figure 5-37 Suspend to Read/Program Latency



Notes:

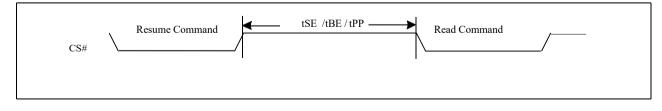
- 1. Please note that Program only available after the Erase-Suspend operation
- 2. To check suspend ready information, please read status register bit15 (SUS2) and bit10(SUS1)

#### 5.38. Program Resume and Erase Resume

The Resume instruction resumes a suspended Page Program, Sector Erase, or Block Erase operation. Before issuing the Resume instruction to restart a suspended erase operation, make sure that there is no Page Program operation in progress.

Immediately after the Serial NOR Flash receives the Resume instruction, the WEL and WIP bits are set to "1" and the SUS2 or SUS1 is cleared to "0". The program or erase operation will continue until finished ("Resume to Read Latency") or until another Suspend instruction is received. A resume-to-suspend latency of tPRS or tERS must be observed before issuing another Suspend instruction ("Resume to Suspend Latency").

#### Figure 5-38 Resume to Read Latency





### 5.39. No Operation (NOP)

The "No Operation" command is only able to terminate the Reset Enable (RSTEN) command and will not affect any other command.

The SIO[3:1] are don't care.

## 5.40. Software Reset (RSTEN/RST)

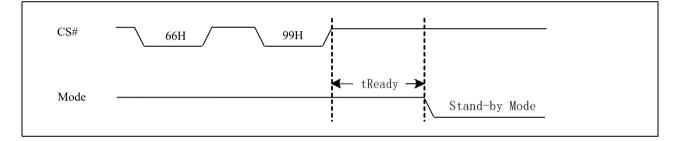
The Software Reset operation combines two instructions: Reset-Enable (RSTEN) command and Reset (RST) command. It returns the device to a standby mode. All the volatile bits and settings will be cleared then, which makes the device return to the default status as power on.

To execute Reset command (RST), the Reset-Enable (RSTEN) command must be executed first to perform the Reset operation. If there is any other command to interrupt after the Reset-Enable command, the

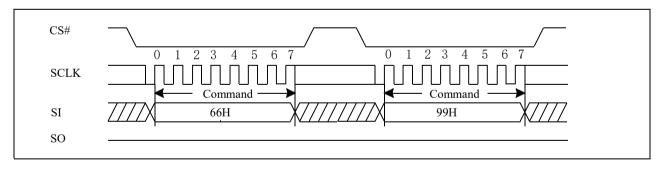
Reset-Enable will be invalid. The SIO[3:1] are "don't care".

If the Reset command is executed during program or erase operation, the operation will be disabled, the data under processing could be damaged or lost.

#### Figure 5-40a Software Reset



#### Figure 5-40b Reset





#### 5.41. Read Unique ID (RUID)

The Read Unique ID command accesses a factory-set read-only 128bit number that is unique to each ZD25Qxx device. The Unique ID can be used in conjunction with user software methods to help prevent copying or cloning of a system.

The Read Unique ID command sequence: CS# goes low  $\rightarrow$  sending Read Unique ID command  $\rightarrow$ Dummy Byte1  $\rightarrow$ Dummy Byte2  $\rightarrow$ Dummy Byte3  $\rightarrow$  Dummy Byte4  $\rightarrow$  128bit Unique ID Out  $\rightarrow$  CS# goes high.

The command sequence is show below.

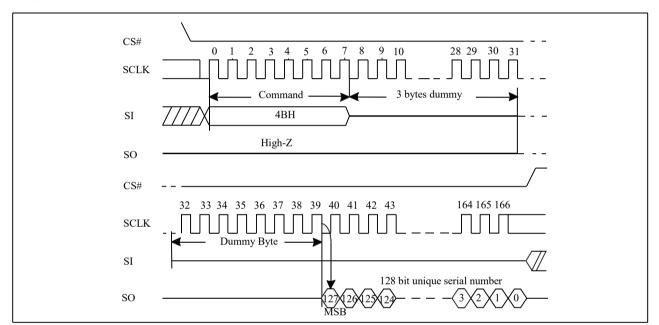


Figure 5-41 Read Unique ID (RUID) Sequence (Command 4B)

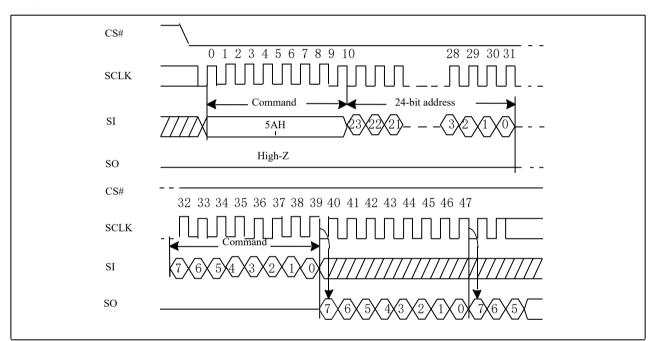


## 5.42. Read SFDP Mode (RDSFDP)

The Serial Flash Discoverable Parameter (SFDP) standard provides a consistent method of describing the functional and feature capabilities of serial flash devices in a standard set of internal parameter tables. These parameter tables can be interrogated by host system software to enable adjustments needed to accommodate divergent features from multiple vendors. The concept is similar to the one found in the Introduction of JEDEC Standard, JESD68 on CFI.

The sequence of issuing RDSFDP instruction is same as FAST\_READ: CS# goes low $\rightarrow$  send RDSFDP instruction (5Ah) $\rightarrow$ send 3 address bytes on SI pin $\rightarrow$  send 1 dummy byte on SI pin $\rightarrow$  read SFDP code on SO $\rightarrow$  to end RDSFDP operation can use CS# to high at any time during data out. The lower byte (A7~A0) of the address is the valid address which is corresponded to the Add in the **Figure 5-42**.

SFDP is a JEDEC Standard, JESD216B.







#### Figure 5-42 Serial Flash Discoverable Parameter (SFDP) Table

Table Signature and Parameter Identification Data Values

Description	Comment	Add(H)	DW Add	Data	Data
		(Byte)	(Bit)		
SFDP Signature	Fixed:50444653H	00H	07:00	53H	53H
		01H	15:08	46H	46H
		02H	23:16	44H	44H
		03H	31:24	50H	50H
SFDP Minor Revision Number	Start from 00H	04H	07:00	00H	06H
SFDP Major Revision Number	Start from 01H	05H	15:08	01H	01H
Number of Parameters Headers	Start from 00H	06H	23:16	01H	01H
Unused	Contains 0xFFH and can never be changed	07H	31:24	FFH	FFH
ID number (JEDEC)	00H: It indicates a JEDEC specified header	08H	07:00	00H	00H
Parameter Table Minor Revision Number	Start from 0x00H	09H	15:08	00H	06H
Parameter Table Major Revision Number	Start from 0x01H	0AH	23:16	01H	01H
Parameter Table Length (in double word)	How many DWORDs in the Parameter table	0BH	31:24	09H	09H
Parameter Table Pointer (PTP)	First address of JEDEC Flash	0CH	07:00	30H	30H
	Parameter table	0DH	15:08	00H	00H
		0EH	23:16	00H	00H
Unused	Contains 0xFFH and can never be changed	0FH	31:24	FFH	FFH
ID Number (TMCDevice Manufacturer ID)	It is indicates TMC manufacturer ID	10H	07:00	BAH	BAH
Parameter Table Minor Revision Number	Start from 0x00H	11H	15:08	00H	00H
Parameter Table Major Revision Number	Start from 0x01H	12H	23:16	01H	01H
Parameter Table Length (in double word)	How many DWORDs in the Parameter table	13H	31:24	03H	03H
Parameter Table Pointer (PTP)	First address of TMC Flash	14H	07:00	90H	90H
	Parameter table	15H	15:08	00H	00H
		16H	23:16	00H	00H
Unused	Contains 0xFFH and can never be changed	17H	31:24	FFH	FFH



Table Parameter Table (0): JEDEC Flash Parameter Tables

Description	Comment	Add(H) (Byte)	DW Add (Bit	Data	Data
Block/Sector Erase Size	00: Reserved; 01: 4KB erase; 10: Reserved; 11: not support 4KB erase		01:00	01b	
Write Granularity	0: 1Byte, 1: 64Byte or larger		02	1b	
Write Enable Instruction Requested for Writing to Volatile Status Registers	0: Nonvolatile status bit 1: Volatile status bit (BP status register bit)	2011	03	0b	Equ
Write Enable Opcode Select for Writing to Volatile Status Registers	0: Use 50H Opcode, 1: Use 06H Opcode, Note: If target flash status register is Nonvolatile, then bits3 and 4 must be set to 00b.	. 30H .	04	0Ь	E5H
Unused	Contains 111b and can never be changed		07:05	111b	
4KB Erase Opcode		31H	15:08	20H	20H
(1-1-2) Fast Read	0=Not support, 1=Support		16	1b	
Address Bytes Number used in addressing flash array	00: 3Byte only, 01: 3 or 4Byte, 10: 4Byte only, 11: Reserved		18:17	00b	
Double Transfer Rate (DTR) clocking	0=Not support, 1=Support	32Н	19	0b	F1H
(1-2-2) FastRead	0=Not support, 1=Support		20	1b	
(1-4- 4) Fast Read	0=Not support, 1=Support		21	1b	
(1-1-4) Fast Read	0=Not support, 1=Support		22	1b	
Unused			23	1b	
Unused		33H	31:24	FFH	FFH
Flash Memory Density		37H:34H	31:00	00FFFI	FFFH
(1-4- 4) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	- 38H	04:00	00100b	. 44H
(1-4- 4) Fast Read Number of Mode Bits	000b:Mode Bits not support	381	07:05	010b	. 441
(1-4- 4) Fast Read Opcode		39Н	15:08	EBH	EBH
(1-1- 4) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	2411	20:16	01000b	0011
(1-1- 4) Fast Read Number of Mode Bits	000b:Mode Bits not support	ЗАН	23:21	000b	08H
(1-1- 4) Fast Read Opcode		3BH	31:24	6BH	6BH



Description	Comment	Add(H) (Byte)	DW Add (Bit)	Data	Data
(1-1- 2) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	ЗСН	04:00	01000Ь	08H
(1-1- 2) Fast Read Number of Mode Bits	000b: Mode Bits not support	эсп	07:05	000b	081
(1-1-2) Fast Read Opcode		3DH	15:08	3BH	3BH
(1-2- 2) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	ЗЕН	20:16	00000Ь	80H
(1-2- 2) Fast Read Number of Mode Bits	000b: Mode Bits not support		23:21	100b	
(1-2- 2) Fast Read Opcode		3FH	31:24	BBH	BBH
(2-2- 2) Fast Read	0=not support 1=support		00	0b	
Unused		4011	03:01	111b	FEII
(4-4- 4) Fast Read	0=not support 1=support	- 40H	04	0b	EEH
Unused			07:05	111b	
Unused		43H:41H	31:08	0xFFH	0xFFH
Unused		45H:44H	15:00	0xFFH	0xFFH
(2-2- 2) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support		20:16	00000Ъ	0.011
(2-2- 2) Fast Read Number of Mode Bits	000b: Mode Bits not support	- 46H	23:21	000ь	00H
(2-2- 2) Fast Read Opcode		47H	31:24	FFH	FFH
Unused		49H:48H	15:00	0xFFH	0xFFH
(4-4- 4) Fast Read Number of Wait states	0 0000b: Wait states (Dummy Clocks) not support	- 4AH	20:16	00000Ъ	- 00H
(4-4- 4) Fast Read Number of Mode Bits	000b: Mode Bits not support	- +AII	23:21	000Ь	0011
(4-4- 4) Fast Read Opcode		4BH	31:24	FFH	FFH
Sector Type 1 Size	Sector/block size=2^N bytes 0x00b: this sector type don't exist	4CH	07:00	0CH	0CH
Sector Type 1 erase Opcode		4DH	15:08	20H	20H
Sector Type 2 Size	Sector/block size=2^N bytes 0x00b: this sector type don't exist	4EH	23:16	0FH	0FH
Sector Type 2 erase Opcode		4FH	31:24	52H	52H
Sector Type 3 Size	Sector/block size=2^N bytes 0x00b: this sector type don't exist	50H	07:00	10H	10H
Sector Type 3 erase Opcode		51H	15:08	D8H	D8H
Sector Type 4 Size	Sector/block size=2^N bytes 0x00b: this sector type don't exist	52H	23:16	00H	00H
Sector Type 4 erase Opcode		53H	31:24	FFH	FFH

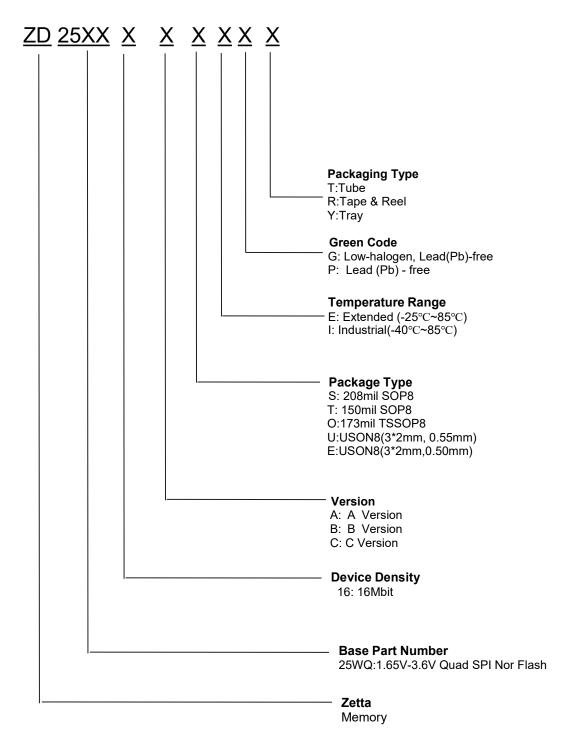


Table Parameter Table (1): Zetta Flash Parameter Tables

Description         Comment         (Byte)         (Bit) $2000H=2.000V$ $PH$	3600H	3600H
Vcc Supply Maximum Voltage       2700H=2.700V       91H:90H       15:00         3600H=3.600V       1650H=1.650V       93H:92H       31:16         Vcc Supply Minimum Voltage       2250H=2.250V       93H:92H       31:16         2350H=2.350V       2350H=2.350V       2700H=2.700V       93H:92H       31:16         HW Reset# pin       0=not support 1=support       8       8       9         HW Hold# pin       0=not support 1=support       9       00       0         SW Reset       0=not support 1=support       9       9       01       0         SW Reset Opcode       0=not support 1=support       9       9       11:04       0       10       10	3600H	3600H
3600H=3.600V	3600H	3600H
1650H=1.650V $2250H=2.250V$ $93H:92H$ $31:16$ $250H=2.350V$ $2350H=2.350V$ $93H:92H$ $31:16$ $1W$ Reset# pin $0=not$ support $1=support$ $93H:92H$ $00$ $HW$ Reset# pin $0=not$ support $1=support$ $00$ $HW$ Hold# pin $0=not$ support $1=support$ $00$ $Deep$ Power Down Mode $0=not$ support $1=support$ $00$ $SW$ Reset $0=not$ support $1=support$ $00$ $SW$ Reset Opcode $0=not$ support $1=support$ $01$ $Program$ Suspend/Resume $0=not$ support $1=support$ $01$ $11:04$ $11:04$ $11:04$ $Vrap$ Around Read mode $0=not$ support $1=support$ $11:04$ $Wrap$ Around Read mode $0=not$ support $1=support$ $11:04$ $Wrap$ Around Read mode $0=not$ support $1=support$ $11:04$ $Wrap$ Around Read mode $0=not$ support $1=support$ $15$ $Wrap$ Around Read mode $0=not$ support $8B$ wra-paround read $96H$ $23:16$		1
Vcc Supply Minimum Voltage2250H=2.250V 2350H=2.350V 2300H=2.30V 2700H=2.700V93H:92H31:16HW Reset# pin0=not support 1=supportHW Hold# pin0=not support 1=supportDeep Power Down Mode0=not support 1=support01SW Reset0=not support 1=support0203SW Reset Opcode0=not support 1=support0111:04Program Suspend/Resume0=not support 1=support11:0413Unused0=not support 1=support1314Wrap Around Read mode0=not support 1=support1515Wrap - Around Read mode Opcode08H:support 8B wra-paround read96H23:16		
Vcc Supply Minimum Voltage2350H=2.350V 2700H=2.700V93H:92H31:16HW Reset# pin0=not support 1=support000HW Hold# pin0=not support 1=support0101Deep Power Down Mode0=not support 1=support0203SW Reset0=not support 1=support0311:04SW Reset OpcodeShould be issue Reset Enable(66H) before Reset cmd.95H:94H11:04Program Suspend/Resume0=not support 1=support1213Unused0=not support 1=support1314Wrap Around Read mode0=not support 1=support1515Wrap - Around Read mode Opcode08H:support 8B wra-paround read96H23:16		
Link2350H=2.350V 2700H=2.700VImage: constant of the section of the sectio	1650H	1650H
HW Reset# pin0=not support 1=support0HW Hold# pin0=not support 1=support01Deep Power Down Mode0=not support 1=support02SW Reset0=not support 1=support03SW Reset OpcodeShould be issue Reset Enable(66H) before Reset cmd.011Program Suspend/Resume0=not support 1=support11:04Unused0=not support 1=support13Unused0=not support 1=support14Wrap Around Read mode0=not support 1=support15Wrap - Around Read mode Opcode08H:support 8B wra-paround read96H		
HW Hold# pin0=not support 1=supportDeep Power Down Mode0=not support 1=supportSW Reset0=not support 1=supportSW Reset OpcodeShould be issue Reset Enable(66H) before Reset cmd.Program Suspend/Resume0=not support 1=supportProgram Suspend/Resume0=not support 1=supportUnused0=not support 1=supportWrap Around Read mode0=not support 1=supportWrap - Around Read mode0=not support 1=supportWrap - Around Read mode0=not support 1=support08H:support 8B wra-paround read96H23:16		
Deep Power Down Mode0=not support 1=supportSW Reset0=not support 1=supportSW Reset OpcodeShould be issue Reset Enable(66H) before Reset cmd.95H:94HProgram Suspend/Resume0=not support 1=supportErase Suspend/Resume0=not support 1=supportUnused0=not support 1=supportWrap Around Read mode0=not support 1=supportWrap - Around Read mode0=not support 1=supportWrap - Around Read mode0=not support 1=support08H:support 8B wra-paround read96H23:16	0b	
SW Reset0=not support 1=supportSW Reset OpcodeShould be issue Reset Enable(66H) before Reset cmd.95H:94H11:04Program Suspend/Resume0=not support 1=support12Erase Suspend/Resume0=not support 1=support13Unused0=not support 1=support14Wrap Around Read mode0=not support 1=support15Wrap - Around Read mode Opcode08H:support 8B wra-paround read96H23:16	1b	
SW Reset OpcodeShould be issue Reset Enable(66H) before Reset cmd.95H:94H11:04Program Suspend/Resume0=not support 1=support12Erase Suspend/Resume0=not support 1=support13Unused0=not support 1=support14Wrap Around Read mode0=not support 1=support15Wrap - Around Read mode Opcode08H:support 8B wra-paround read96H	1b	
SW Reset Opcodebefore Reset cmd.95H:94H11:04Program Suspend/Resume0=not support 1=support12Erase Suspend/Resume0=not support 1=support13Unused0=not support 1=support14Wrap Around Read mode0=not support 1=support15Wrap - Around Read mode Opcode96H23:1608H:support 8B wra-paround read15	1b	
before Reset cmd.12Program Suspend/Resume0=not support 1=supportErase Suspend/Resume0=not support 1=supportUnused11Wrap Around Read mode0=not support 1=supportWrap - Around Read mode0=not support 1=supportWrap - Around Read mode0=not support 1=support08H:support 8B wra-paround read14	1001 1001b	F99EH
Erase Suspend/Resume       0=not support 1=support       13         Unused       14       14         Wrap Around Read mode       0=not support 1=support       15         Wrap - Around Read mode Opcode       96H       23:16         08H:support 8B wra-paround read       14	(99H)	F99EH
Unused     14       Wrap Around Read mode     0=not support 1=support       Wrap - Around Read mode Opcode     96H       08H:support 8B wra-paround read     14	1b	-
Wrap Around Read mode     0=not support 1=support     15       Wrap - Around Read mode Opcode     96H     23:16       08H:support 8B wra-paround read     1	1b	
Wrap - Around Read mode Opcode     96H     23:16       08H:support 8B wra-paround read     0	1b	
08H:support 8B wra-paround read	1b	
	77H	77H
16H:8B&16B		64H
Wrap - Around Read data length 97H 31:24	64H	
Wrap - Around Read data length32H:8B&16B&32B97H31:24		
64H:8B&16B&32B&64B		
Individualblock lock 0=not support 1=support 00	0b	
Individual block lock bit 0=Volatile 01	0b	
(Volatile/Nonvolatile) 1=Nonvolatile	00	
Individual block lock Opcode 09:02	FFH	
Individual blocklock Volatile 0=protect 1=unprotect 10	0b	EBFCH
protect bit default protect status 9BH:98H	00	ЕБГСП
Secured OTP 0=not support 1=support 11	1b	
Read Lock   0=not support   1=support   12	0b	]
Permanent Lock     0=not support     1=support       13	1b	1
Unused 15:14	11b	1
Unused 31:16	FFFFH	FFFFH



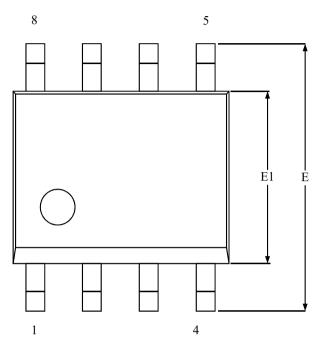
# 6. Ordering Information

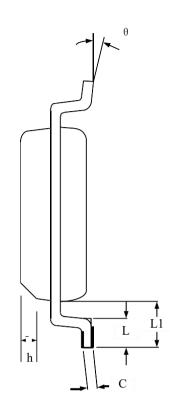


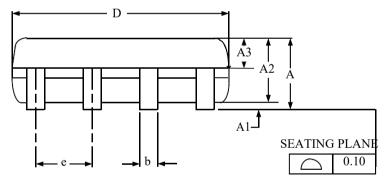
**Ordering Information** 

# 7. Package Information

## 7.1-Lead SOP(150mil)







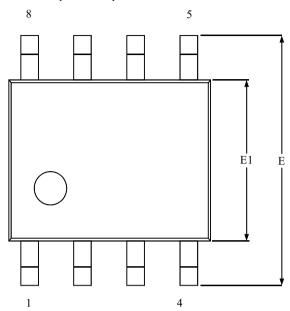
## Dimensions

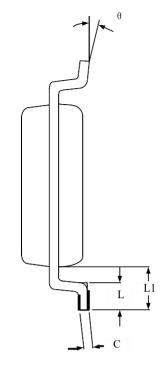
Symb	loc	Α	A1	A2	A3	b	С	D	Е	E1	е	1	L1	h	θ
Unit			AI	A2	AJ	U	C				C	L			U
	Min	-	0.10	1.30	0.6	0.39	0.20	4.80	5.80	3.80		0.50		0.25	0
mm	Nom	-	-	1.40	0.65	-	-	4.90	5.90	3.90	1.27 BSC	-	1.05	-	-
	Max	1.75	0.225	1.50	0.7	0.47	0.24	5.00	6.20	4.00		0.80		0.50	8
	Min	-	0.004	0.051	0.024	0.015	0.008	0.189	0.228	0.150		0.020		0.010	0
Inch	Nom	-	-	0.055	0.026	-	-	0.193	0.236	0.154	0.050 BSC	-	0.041	-	-
	Max	0.069	0.009	0.059	0.028	0.019	0.009	0.197	0.244	0.158		0.031		0.020	8

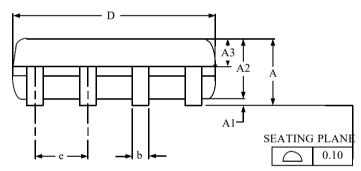
TITLE	DRAWING NO.	REV	REF
8-Lead SOP(150mil)		A	JEDEC MS-012



## 7.2-Lead SOP(208mil)







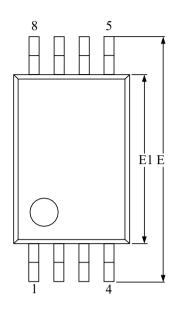
## Dimensions

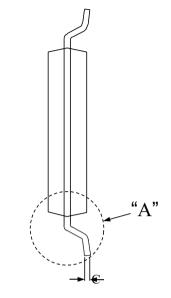
Symb	loc	А	A1	A2	A3	٢	С	D	Е	E1		-	11	θ
Unit		A	AI	AZ	AS	b	C	D	E		е	L	L1	0
	Min	1.75	0.05	1.70	0.55	0.38		5.13	7.70	5.18		0.50	1.21	0
mm	Nom	1.9	0.1	1.80	0.60	0.43	0.203 REF	5.23	7.90	5.28	1.27 REF	0.65	1.31	-
	Max	2.05	0.15	1.90	0.65	0.48		5.33	8.10	5.38		0.80	1.41	8
	Min	0.069	0.002	0.067	0.022	0.015		0.202	0.303	0.204	0.050	0.020	0.048	0
Inch	Nom	0.075	0.004	0.071	0.024	0.017	0.008 REF	0.206	0.311	0.208	0.050 REF	0.026	0.052	-
	Max	0.081	0.006	0.075	0.026	0.019		0.210	0.319	0.212		0.031	0.056	8

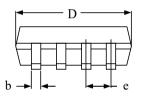
TITLE	DRAWING NO.	REV	REF
8-Lead SOP(208mil)		A	

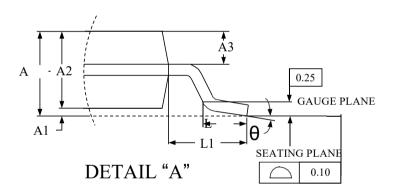


## 7.3-Lead TSSOP(173mil)









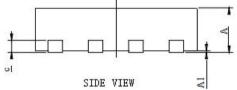
<b>D</b> '			
1)	mer	ารเด	ns
וט	IIICI	ISIC	כווי

Dimen														
Symbo	Symbol		A1	A2	A3	b	с	D	Е	E1	е		L1	θ
Unit		A	AI	AZ	AS	U	C	U		C 1	e	L		0
	Min	-	0.05	0.90	0.39	0.20	0.13	2.90	6.20	4.30		0.45		0
mm	Nom	-	-	1.00	0.44	-	-	3.00	6.40	4.40	0.65 BSC	-	1.00 REF	-
	Max	1.20	0.15	1.05	0.49	0.28	0.17	3.10	6.60	4.50	200	0.75		8
	Min	-	0.002	0.035	0.015	0.008	0.005	0.114	0.244	0.169		0.018	0.000	0
Inch	Nom	-	-	0.039	0.017	-	-	0.118	0.252	0.173	0.026 BSC	-	0.039 REF	-
	Max	0.047	0.006	0.041	0.019	0.011	0.007	0.122	0.260	0.177		0.030		8

TITLE	DRAWING NO.	REV	REF
8-lead TSSOP		A	JEDEC MO-153

## D Nd -1 17 T × Π D2 E E PIN 1# aser Ma 1 1 2 2 .b1 TOP VIEW EXPOSED THERMAL PAD ZONE BOTTOM VIEW

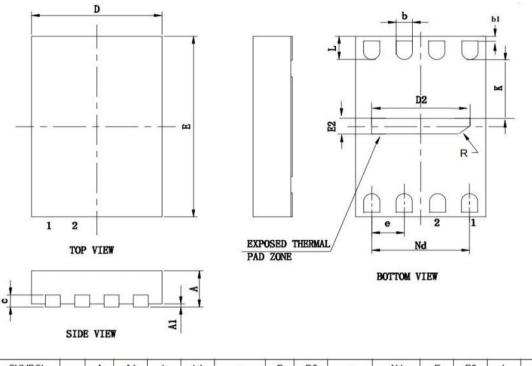
## 7.4-Land USON(3x2mm, thickness 0.55mm)



SYMBOL		,	٩	A1	b	b1	С	D	D2	е	Nd	E	E2	L	R	к	L2
	MIN	0.5	0.4	0	0.2			1.9	1.3	5		2.9	1.2	0.25	0.2	0.5	0.6
MILLIMETER	NOM	0.55	0.45	0.02	0.25	0.18REF	0.152REF	2	1.4	0.50BSC	1.50BSC	3	1.3	0.3	0.25	0.55	-
8	MAX	0.6	0.5	0.05	0.3			2.1	1. <mark>5</mark>			3.1	1.4	0.35	0.3	0.6	17.



## 7.5-Land USON(3x2mm, thickness 0.50mm)



SYMBOL		Α	A1	b	b1	С	D	D2	е	Nd	E	E2	L	K	R
	MIN	0.45	-	0.20	0.05		1.95	1.50			2.95	0.10	0.40	0.85	
MILLIMETER	NOM	0.50	0.02	0.25	0.10	0.152REF	2.00	1.60	0.50BSC	1.50BSC	3.00	0.20	0.45	0.95	0.25
	MAX	0.55	0.05	0.30	0.15		2.05	1.70			3.05	0.30	0.50	1.05	



# 8. Revision History

Rev.	Date	Description
1.0	2020-01-02	Initial Release
1.1	2020-05-10	Modify Package Information